# ANALOG DEVICES

# Single-Channel, 16-Bit Current and Voltage Output DAC with Dynamic Power Control and HART Connectivity

### **Data Sheet**

#### **FEATURES**

16-bit resolution and monotonicity DPC for thermal management Current/voltage output available on a single terminal Current output ranges: 0 mA to 20 mA, 4 mA to 20 mA, 0 mA to 24 mA, ±20 mA, ±24 mA, -1 mA to +22 mA Voltage output ranges (with 20% overrange): 0 V to 5 V, 0 V to 10 V, ±5 V, and ±10 V User-programmable offset and gain Advanced on-chip diagnostics, including a 12-bit ADC On-chip reference Robust architecture, including output fault protection -40°C to +115°C temperature range 32-lead, 5 mm × 5 mm LFCSP package

#### APPLICATIONS

Process control Actuator control Channel isolated analog outputs Programmable logic controller (PLC) and distributed control systems (DCS) applications HART network connectivity

#### **GENERAL DESCRIPTION**

The AD5758 is a single-channel, voltage and current output digitalto-analog converter (DAC) that operates with a power supply range from -33 V (minimum) on AV<sub>SS</sub> to +33 V (maximum) on AV<sub>DD1</sub> with a maximum operating voltage between the two rails of 60 V. On-chip dynamic power control (DPC) minimizes package power dissipation, which is achieved by regulating the supply voltage (V<sub>DPC+</sub>) to the VI<sub>OUT</sub> output driver circuitry from 5 V to 27 V using a buck dc-to-dc converter, optimized for minimum on-chip power dissipation. The C<sub>HART</sub> pin enables a HART<sup>\*</sup> signal to be coupled onto the current output.

**AD5758** 

The device uses a versatile 4-wire serial peripheral interface (SPI) that operates at clock rates of up to 50 MHz and is compatible with standard SPI, QSPI<sup>™</sup>, MICROWIRE<sup>™</sup>, DSP, and microcontroller interface standards. The interface also features an optional SPI cyclic redundancy check (CRC) and a watchdog timer (WDT). The AD5758 offers improved diagnostic features from its predecessors, such as output current monitoring and an integrated 12-bit diagnostic analog-to-digital converter (ADC). Additional robustness is provided by the inclusion of a fault protection switch on the VIOUT, +VSENSE, and −VSENSE pins.

#### **PRODUCT HIGHLIGHTS**

- 1. Range of diagnostic features, including integrated ADC.
- 2. DPC, using an integrated buck dc-to-dc converter for thermal management, enabling higher channel count in smaller size module housing.
- 3. Programmable power control (PPC) mode to enable faster settling time (15 µs typical).
- 4. 16-bit performance.
- 5. HART compliant.

#### **COMPANION PRODUCTS**

Product Family: AD5755-1, AD5422 HART Modem: AD5700, AD5700-1 External References: ADR431, ADR3425, ADR4525 Digital Isolators: ADuM142D, ADuM141D Power: LT8300, ADP2360, ADM6339

Rev. 0

#### **Document Feedback**

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#### **REVISION HISTORY**

5/2018—Revision 0: Initial Version

| Voltage Output                                   |
|--|
| Fault Protection Switches                        |
| Current Output                                   |
| Internal Current Output Monitor                  |
| HART Connectivity                                |
| Digital Slew Rate Control                        |
| Device Under Test (DUT) Address Pins             |
| Watchdog Timer (WDT)                             |
| User Digital Offset and Gain Control             |
| DAC Output Update and Data Integrity Diagnostics |
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| Driving Inductive Loads                          |

### FUNCTIONAL BLOCK DIAGRAM



### **SPECIFICATIONS**

 $AV_{DD1} = V_{DPC+} = 15 \text{ V}$ ; dc-to-dc converter disabled;  $AV_{DD2} = 5 \text{ V}$ ;  $AV_{SS} = -15 \text{ V}$ ;  $V_{LOGIC} = 1.71 \text{ V}$  to 5.5 V; AGND = DGND = REFGND = PGND1 = 0 V; REFIN = 2.5 V external; voltage output:  $R_L = 1 \text{ k}\Omega$ ,  $C_L = 220 \text{ pF}$ ; current output:  $R_L = 300 \Omega$ ; all specifications at  $T_A = -40^{\circ}\text{C}$  to  $+115^{\circ}\text{C}$ , unless otherwise noted.

#### Table 1.

| Parameter  | Min    | Тур    | Max    | Unit       | Test Conditions/Comments   |  |  |
|--|--------|--------|--------|------------|--|--|--|
| VOLTAGE OUTPUT   |        |        |        |            | Statement of available ranges rather than absolute minimum and maximum values                                      |  |  |
| Output Voltage Ranges (Vout)   | 0      |        | 5      | V          | Trimmed V <sub>OUT</sub> ranges  |  |  |
|  | 0      |        | 10     | V          | -  |  |  |
|  | -5     |        | +5     | V          |  |  |  |
|  | -10    |        | +10    | V          |  |  |  |
| Output Voltage Overranges  | 0      |        | 6      | V          | Untrimmed overranges   |  |  |
|  | 0      |        | 12     | V          |  |  |  |
|  | -6     |        | +6     | V          |  |  |  |
|  | -12    |        | +12    | V          |  |  |  |
| Output Voltage Offset Ranges   | -0.3   |        | +5.7   | V          | Untrimmed negatively offset ranges   |  |  |
|  | -0.4   |        | +11.6  | V          |  |  |  |
| Resolution   | 16     |        |        | Bits       |  |  |  |
| VOLTAGE OUTPUT ACCURACY  |        |        |        |            | Loaded and unloaded, accuracy specifications refer to trimmed $V_{\text{OUT}}$ ranges only, unless otherwise noted |  |  |
| Total Unadjusted Error (TUE)   | -0.05  |        | +0.05  | % FSR      |  |  |  |
|  | -0.01  |        | +0.01  | % FSR      | $T_A = 25^{\circ}C$  |  |  |
| TUE Long-Term Stability <sup>1</sup>   |        | 15     |        | ppm FSR    | Drift after 1000 hours, T <sub>J</sub> = 150°C   |  |  |
| Output Drift   |        | 0.35   | 1.5    | ppm FSR/°C | Output drift   |  |  |
| Relative Accuracy (INL)  | -0.006 |        | +0.006 | % FSR      | All ranges   |  |  |
| Differential Nonlinearity (DNL)  | -1     |        | +1     | LSB        | Guaranteed monotonic, all ranges   |  |  |
| Zero-Scale Error   | -0.02  | ±0.002 | +0.02  | % FSR      |  |  |  |
| Zero-Scale Error Temperature<br>Coefficient (TC) <sup>2</sup>                |        | ±0.3   |        | ppm FSR/°C |  |  |  |
| Bipolar Zero Error   | -0.015 | +0.001 | +0.015 | % FSR      | ±5 V, ±10 V  |  |  |
| Bipolar Zero Error TC <sup>2</sup>   |        | ±0.3   |        | ppm FSR/°C | ±5 V, ±10 V  |  |  |
| Offset Error   | -0.02  | ±0.002 | +0.02  | % FSR      |  |  |  |
| Offset Error TC <sup>2</sup>   |        | ±0.3   |        | ppm FSR/°C |  |  |  |
| Gain Error   | -0.02  | ±0.001 | +0.02  | % FSR      |  |  |  |
| Gain Error TC <sup>2</sup>   |        | ±0.3   |        | ppm FSR/°C |  |  |  |
| Full-Scale Error   | -0.02  | ±0.001 | +0.02  | % FSR      |  |  |  |
| Full-Scale Error TC <sup>2</sup>   |        | ±0.3   |        | ppm FSR/°C |  |  |  |
| VOLTAGE OUTPUT<br>CHARACTERISTICS  |        |        |        |            |  |  |  |
| Headroom   |        | 1.5    | 2.5    | V          | With respect to V <sub>DPC+</sub> supply   |  |  |
| Footroom   |        | 1.5    | 2.5    | V          | With respect to the AV <sub>SS</sub> supply  |  |  |
| Short-Circuit Current  |        | 16     |        | mA         |  |  |  |
| Load <sup>2</sup>  | 1      |        |        | kΩ         | For specified performance  |  |  |
| Capacitive Load Stability <sup>2</sup>                                       |        |        | 10     | nF         |  |  |  |
|  |        |        | 2      | μF         | External compensation capacitor of 220 pF connected  |  |  |
| DC Output Impedance  |        | 5      |        | mΩ         |  |  |  |
| DC Power Supply Rejection<br>Ratio (PSRR)                                    |        | 10     |        | μV/V       |  |  |  |
| V <sub>OUT</sub> /–V <sub>SENSE</sub> Common-Mode<br>Rejection Ration (CMRR) |        | 10     |        | μV/V       | Error in V <sub>OUT</sub> voltage due to changes in –V <sub>SENSE</sub> voltage                                    |  |  |

## **Data Sheet**

| Parameter                                 | Min    | Тур    | Max    | Unit       | Test Conditions/Comments                                  |
|---|--------|--------|--------|------------|---|
| CURRENT OUTPUT                            |        |        |        |            |   |
| Output Current Ranges (Iout)              | 0      |        | 24     | mA         |   |
|   | 0      |        | 20     | mA         |   |
|   | 4      |        | 20     | mA         |   |
|   | -20    |        | +20    | mA         |   |
|   | -24    |        | +24    | mA         |   |
|   | -1     |        | +22    | mA         |   |
| Resolution                                | 16     |        |        | Bits       |   |
| CURRENT OUTPUT ACCURACY                   |        |        |        |            | Assumes ideal 13.7 kΩ resistor                            |
| (EXTERNAL R <sub>SET</sub> ) <sup>3</sup> |        |        |        |            |   |
| Unipolar Ranges                           |        |        |        |            | 4 mA to 20 mA, 0 mA to 20 mA, and 0 mA to 24 mA ranges    |
| TUE                                       | -0.06  |        | +0.06  | % FSR      |   |
|   | -0.012 |        | +0.012 | % FSR      | $T_A = 25^{\circ}C$                                       |
| TUE Long-Term Stability                   |        | 125    |        | ppm FSR    | Drift after 1000 hours, T <sub>J</sub> = 150°C            |
| Output Drift                              |        | 3      | 7      | ppm FSR/°C |   |
| INL                                       | -0.006 |        | +0.006 | % FSR      |   |
| DNL                                       | -1     |        | +1     | LSB        | Guaranteed monotonic                                      |
| Zero-Scale Error                          | -0.03  | ±0.002 | +0.03  | % FSR      |   |
| Zero-Scale TC <sup>2</sup>                |        | ±0.5   |        | ppm FSR/°C |   |
| Offset Error                              | -0.035 | ±0.001 | +0.035 | % FSR      |   |
| Offset Error TC <sup>2</sup>              |        | ±0.7   |        | ppm FSR/°C |   |
| Gain Error                                | -0.05  | ±0.001 | +0.05  | % FSR      |   |
| Gain Error TC <sup>2</sup>                |        | ±4     |        | ppm FSR/°C |   |
| Full-Scale Error                          | -0.06  | ±0.001 | +0.06  | % FSR      |   |
| Full-Scale Error TC <sup>2</sup>          |        | ±3.5   |        | ppm FSR/°C |   |
| Bipolar Ranges                            |        |        |        |            | $\pm$ 20 mA, $\pm$ 24 mA, and $-1$ mA to $+$ 22 mA ranges |
| Total Unadjusted Error (TUE)              | -0.13  |        | +0.13  | % FSR      |   |
|   | -0.014 |        | +0.014 | % FSR      | $T_A = 25^{\circ}C$                                       |
| TUE Long-Term Stability <sup>1</sup>      |        | 125    |        | ppm FSR    | Drift after 1000 hours, T <sub>J</sub> = 150°C            |
| Output Drift                              |        | 12     | 15.5   | ppm FSR/°C |   |
| INL                                       | -0.01  |        | +0.01  | % FSR      |   |
| DNL                                       | -1     |        | +1     | LSB        | Guaranteed monotonic                                      |
| Zero-Scale Error                          | -0.04  | ±0.002 | +0.04  | % FSR      |   |
| Zero-Scale TC <sup>2</sup>                |        | ±0.5   |        | ppm FSR/°C |   |
| Bipolar Zero Error                        | -0.02  | ±0.002 | +0.02  | % FSR      |   |
| Bipolar Zero Error TC <sup>2</sup>        |        | ±0.4   |        | ppm FSR/°C |   |
| Offset Error                              | -0.15  | ±0.002 | +0.15  | % FSR      |   |
| Offset Error TC <sup>2</sup>              |        | ±12    |        | ppm FSR/°C |   |
| Gain Error                                | -0.25  | ±0.003 | +0.25  | % FSR      |   |
| Gain Error TC <sup>2</sup>                |        | ±22    |        | ppm FSR/°C |   |
| Full-Scale Error                          | -0.12  | ±0.002 | +0.12  | % FSR      |   |
| Full-Scale Error TC <sup>2</sup>          |        | ±11    |        | ppm FSR/°C |   |

| Parameter                            | Min   | Тур    | Max   | Unit       | Test Conditions/Comments   |
|--------------------------------------|-------|--------|-------|------------|--|
| CURRENT OUTPUT ACCURACY              |       |        |       |            |  |
| (INTERNAL R <sub>SET</sub> )         |       |        |       |            |  |
| Unipolar Ranges                      |       |        |       |            | 4 mA to 20 mA, 0 mA to 20 mA, and 0 mA to 24 mA ranges   |
| TUE                                  | -0.12 |        | +0.23 | % FSR      |  |
| TUE Long-Term Stability <sup>1</sup> |       | 380    |       | ppm FSR    | Drift after 1000 hours, T <sub>J</sub> = 150°C   |
| Output Drift                         |       | 6      | 21    | ppm FSR/°C | Output drift   |
| INL                                  | -0.01 |        | +0.01 | % FSR      |  |
| DNL                                  | -1    |        | +1    | LSB        | Guaranteed monotonic   |
| Zero-Scale Error                     | -0.06 | ±0.002 | +0.06 | % FSR      |  |
| Zero-Scale TC <sup>2</sup>           |       | ±0.5   |       | ppm FSR/°C |  |
| Offset Error                         | -0.06 | ±0.001 | +0.06 | % FSR      |  |
| Offset Error TC <sup>2</sup>         |       | ±1     |       | ppm FSR/°C |  |
| Gain Error                           | -0.12 | ±0.005 | +0.18 | % FSR      |  |
| Gain Error TC <sup>2</sup>           |       | ±4.5   |       | ppm FSR/°C |  |
| Full-Scale Error                     | -0.15 | ±0.005 | 0.23  | % FSR      |  |
| Full-Scale Error TC <sup>2</sup>     |       | ±3.5   |       | ppm FSR/°C |  |
| Bipolar Ranges                       |       |        |       |            | $\pm$ 20 mA, $\pm$ 24 mA, and $-1$ mA to $+$ 22 mA range                                       |
| TUE                                  | -0.15 |        | +0.23 | % FSR      |  |
| TUE Long-Term Stability <sup>1</sup> |       | 380    |       | ppm FSR    | Drift after 1000 hours, T <sub>J</sub> = 150°C   |
| Output Drift                         |       | 12     | 22    | ppm FSR/°C | Output drift   |
| INL                                  | -0.01 |        | +0.01 | % FSR      |  |
| DNL                                  | -1    |        | +1    | LSB        | Guaranteed monotonic   |
| Zero-Scale Error                     | -0.06 | ±0.002 | +0.06 | % FSR      |  |
| Zero-Scale TC <sup>2</sup>           |       | ±0.5   |       | ppm FSR/°C |  |
| Bipolar Zero Error                   | -0.02 | ±0.002 | +0.02 | % FSR      |  |
| Bipolar Zero Error TC <sup>2</sup>   |       | ±0.3   |       | ppm FSR/°C |  |
| Offset Error                         | -0.15 | ±0.004 | +0.15 | % FSR      |  |
| Offset Error TC <sup>2</sup>         |       | ±10    |       | ppm FSR/°C |  |
| Gain Error                           | -0.3  | ±0.007 | +0.3  | % FSR      |  |
| Gain Error TC <sup>2</sup>           |       | ±23    |       | ppm FSR/°C |  |
| Full-Scale Error                     | -0.14 | ±0.005 | 0.16  | % FSR      |  |
| Full-Scale Error TC <sup>2</sup>     |       | ±10    |       | ppm FSR/°C |  |
| CURRENT OUTPUT                       |       |        |       |            |  |
| CHARACTERISTICS                      |       |        |       |            |  |
| Headroom                             |       | 1.6    | 2.5   | V          | With respect to $V_{DPC+}$ supply; the current   |
|                                      |       |        |       |            | output compliance voltage associated with this headroom margin is $V_{DPC+} - 2.5 V$           |
| Footroom                             |       | 1.7    | 2.5   | V          | With respect to AV <sub>ss</sub> supply  |
| Resistive Load <sup>2</sup>          |       |        | 1000  | Ω          | The dc-to-dc converter is characterized with   |
|                                      |       |        |       |            | a maximum load of 1 k $\Omega$ , chosen such that headroom/footroom compliance is not exceeded |
| Output Impedance                     |       | 100    |       | MΩ         | Midscale output  |
| DC PSRR                              |       | 0.1    |       | μA/V       |  |

## **Data Sheet**

| Parameter                                   | Min   | Тур  | Max      | Unit   | Test Conditions/Comments  |
|---|-------|------|----------|--------|---|
| REFERENCE INPUT/OUTPUT                      |       |      |          |        |   |
| Reference Input                             |       |      |          |        |   |
| Reference Input Voltage <sup>2</sup>        | 2.497 | 2.5  | 2.503    | V      | For specified performance   |
| DC Input Impedance                          | 55    | 120  |          | MΩ     |   |
| Reference Output                            |       |      |          |        |   |
| Output Voltage                              | 2.497 | 2.5  | 2.503    | V      | $T_A = 25^{\circ}C$   |
| Reference TC <sup>2</sup>                   | -10   |      | +10      | ppm/°C |   |
| Output Noise (0.1 Hz to 10 Hz) <sup>2</sup> |       | 7    |          | μV р-р |   |
| Noise Spectral Density <sup>2</sup>         |       | 80   |          | nV/√Hz | At 10 kHz   |
| Output Voltage Drift vs. Time <sup>1</sup>  |       | 650  |          | ppm    | Drift after 1000 hours, T <sub>J</sub> = 150°C  |
| Capacitive Load <sup>2</sup>                |       |      | 1000     | nF     |   |
| Load Current                                |       | 3    |          | mA     |   |
| Short-Circuit Current                       |       | 5    |          | mA     |   |
| Line Regulation                             |       | 1    |          | ppm/V  |   |
| Load Regulation                             |       | 80   |          | ppm/mA |   |
| Thermal Hysteresis <sup>2</sup>             |       | 150  |          | ppm    |   |
|   |       | 150  |          | ppm    |   |
| Output Voltage                              |       | 3.3  |          | v      |   |
| Output Voltage TC <sup>2</sup>              |       | 25   |          | ppm/°C |   |
| Output Voltage Accuracy                     | -2    | 23   | +2       | %      |   |
| Externally Available Current                | -2    |      | +2<br>30 | mA     |   |
| Short-Circuit Current                       |       | 55   | 30       | mA     |   |
|   |       | 0.8  |          | mV/mA  |   |
| Load Regulation                             |       | 0.8  |          |        | Decomposed of execution   |
| Capacitive Load                             |       | 0.1  |          | μF     | Recommended operation   |
| DC-TO-DC                                    |       | 1 25 |          |        |   |
| Start-Up Time                               |       | 1.25 |          | ms     |   |
| Switch                                      |       |      |          |        |   |
| Peak Current Limit <sup>2</sup>             | 150   |      | 400      | mA     | User-programmable in 50 mA steps via the<br>DCDC_CONFIG2 register   |
| Oscillator                                  |       |      |          |        |   |
| Oscillator Frequency (f <sub>sw</sub> )     |       | 500  |          | kHz    |   |
| Minimum Duty Cycle                          |       | 5    |          | %      |   |
| Current Output DPC Mode                     |       |      |          |        | Current output dynamic power control mode   |
| V <sub>DPC+</sub> Voltage Range             | 4.95  |      | 27       | V      | Assuming sufficient supply margin between $AV_{DD1}$ and $V_{DPC+}$ ; see the Power Dissipation Control section for further details; maximum operating range of $ V_{DPC+}$ to $AV_{SS}  = 50 V$                          |
| V <sub>DPC+</sub> Headroom                  |       | 2.1  |          | V      | Typical voltage required between $VI_{OUT}$ and $V_{DPC+}$ ; only applicable when dc-to-dc converter is in regulation (that is, load is sufficiently high)  |
| Current Output PPC Mode                     |       |      |          |        | PPC mode  |
| V <sub>DPC+</sub> Voltage Range             | 5.43  |      | 28.48    | V      | Assuming sufficient supply margin between<br>$AV_{DD1}$ and $V_{DPC+}$ ; see the Power Dissipation<br>Control section and Table 18 for further details;<br>maximum operating range of $ V_{DPC+}$ to $AV_{SS}  =$<br>50 V |
| V <sub>DPC+</sub> Voltage Accuracy          | -500  |      | +500     | mV     | Only applicable when dc-to-dc is operating in regulation (that is, load is sufficiently high)   |

| Parameter   | Min                          | Тур  | Max                    | Unit  | Test Conditions/Comments   |
|---|------------------------------|------|------------------------|-------|--|
| Voltage Output DPC Mode                             |                              |      |                        |       | Voltage output dynamic power control mode  |
| V <sub>DPC+</sub> Voltage Range                     | 5                            | 15   | 25                     | V     | $5 V = -V_{SENSE (MIN)} + 15 V$ ; $25 V = -V_{SENSE (MAX)} + 15 V$ ;<br>assuming sufficient supply margin between $AV_{DDT}$<br>and $V_{DPC+}$ ; see the Power Dissipation Control<br>section for further details; maximum operating |
| V <sub>DPC+</sub> Voltage Accuracy                  | -500                         |      | +500                   | mV    | range of $ V_{DPC+}$ to $AV_{SS}  = 50 V$<br>Only applicable when dc-to-dc is operating in<br>regulation (that is, load sufficiently high)   |
| FAULT PROTECTION SWITCH                             |                              |      |                        |       |  |
| On Resistance, R <sub>ON</sub>                      |                              | 6.5  |                        | Ω     | $T_A = 25^{\circ}C$  |
| On Time, ton  |                              | 10   |                        | μs    |  |
| Off Time, t <sub>OFF</sub>                          |                              | 200  |                        | ns    |  |
| Overvoltage Response Time,<br>t <sub>RESPONSE</sub> |                              | 250  |                        | ns    |  |
| Overvoltage Recovery Time,<br>trecovery             |                              | 3.2  |                        | μs    |  |
| Overvoltage Leakage Current                         |                              | ±30  |                        | μΑ    | Fault protection switch sinks current for a<br>positive fault and sources current for a<br>negative fault  |
| ADC   |                              |      |                        |       |  |
| Resolution  |                              | 12   |                        | Bits  |  |
| Total Error   |                              | ±0.3 |                        | % FSR | Table 18 lists all ADC input nodes   |
| Conversion Time <sup>2</sup>                        |                              | 100  |                        | μs    |  |
| DIGITAL INPUTS                                      |                              |      |                        |       |  |
| Input Voltage                                       |                              |      |                        |       |  |
| $3~V \le V_{\text{LOGIC}} \le 5.5~V$                |                              |      |                        |       |  |
| High, V⊪  | $0.7 	imes V_{LOGIC}$        |      |                        | V     |  |
| Low, V <sub>IL</sub>                                |                              |      | $0.3 \times V_{LOGIC}$ | V     |  |
| $1.71~V \leq V_{\text{LOGIC}} < 3~V$                |                              |      |                        |       |  |
| High, V <sub>IH</sub>                               | $0.8 \times V_{LOGIC}$       |      |                        | V     |  |
| Low, V <sub>IL</sub>                                |                              |      | $0.2 \times V_{LOGIC}$ | V     |  |
| Input Current                                       | -1.5                         |      | +1.5                   | μΑ    | Per pin, internal pull-down on SCLK, SDI, RESET, and LDAC; internal pull-up on SYNC  |
| Pin Capacitance <sup>2</sup>                        |                              | 2.4  |                        | pF    | Per pin  |
| DIGITAL OUTPUTS<br>SDO                              |                              |      |                        |       |  |
| Output Voltage                                      |                              |      |                        |       |  |
| Low, Vol  |                              |      | 0.4                    | V     | Sinking 200 μA   |
| <b>High, V</b> он                                   | VLOGIC - 0.2                 |      |                        | V     | Sourcing 200 μA  |
| High Impedance Leakage<br>Current                   | -1                           |      | +1                     | μΑ    |  |
| High Impedance Output                               |                              | 2.2  |                        | pF    |  |
| FAULT   |                              |      |                        |       |  |
| Output Voltage                                      |                              |      |                        |       |  |
| Low, V <sub>OL</sub>                                |                              |      | 0.4                    | V     | 10 k $\Omega$ pull-up resistor to V <sub>LOGIC</sub>   |
|   |                              | 0.6  |                        | V     | At 2.5 mA  |
| High, V <sub>он</sub>                               | V <sub>LOGIC</sub> –<br>0.05 |      |                        | V     | 10 k $\Omega$ pull-up resistor to V <sub>LOGIC</sub>   |

### **Data Sheet**

| Parameter                              | Min   | Тур   | Мах  | Unit | Test Conditions/Comments   |
|--|-------|-------|------|------|--|
| POWER REQUIREMENTS                     |       |       |      |      |  |
| Supply Voltages                        |       |       |      |      |  |
| AV <sub>DD1</sub> <sup>4</sup>         | 7     |       | 33   | V    | Maximum operating range of $ AV_{DD1}$ to $AV_{SS}  = 60 V$  |
| AV <sub>DD2</sub>                      | 5     |       | 33   | V    | Maximum operating range of $ AV_{DD2}$ to $AV_{SS}  = 50 \text{ V}$  |
| AV <sub>55</sub> <sup>4</sup>          | -33   |       | 0    | V    | Maximum operating range of $ AV_{DD1}$ to $AV_{SS}  = 60$ V; for bipolar output ranges, $V_{OUT}/I_{OUT}$ head-<br>room must be obeyed when calculating $AV_{SS}$ maximum; for unipolar current output ranges,<br>$AV_{SS}$ maximum = 0 V; for unipolar voltage<br>output ranges, $AV_{SS}$ maximum = -2.5 V |
| VLOGIC                                 | 1.71  |       | 5.5  | V    |  |
| Supply Quiescent Currents <sup>4</sup> |       |       |      |      | Quiescent current, assuming no load current  |
| Aldd1                                  |       | 0.05  | 0.1  | mA   | Voltage output mode, dc-to-dc converter<br>enabled but not active  |
|  |       | 0.05  | 0.1  | mA   | Current output mode, dc-to-dc converter<br>enabled but not active  |
| Al <sub>DD2</sub>                      |       | 3.3   | 3.6  | mA   | Voltage output mode, dc-to-dc converter<br>enabled but not active  |
|  |       | 2.9   | 3.1  | mA   | Current output mode, dc-to-dc converter<br>enabled but not active  |
| Alss                                   | -1.4  | -1.1  |      | mA   | Voltage output mode  |
|  | -3.0  | -2.3  |      | mA   | Bipolar current output mode  |
|  | -0.26 | -0.23 |      | mA   | Unipolar current output mode   |
| ILOGIC                                 |       |       | 0.01 | mA   | $V_{IH} = V_{LOGIC}, V_{IL} = DGND$  |
| I <sub>DPC+</sub>                      |       | 1.0   | 1.3  | mA   | Voltage output mode  |
|  |       | 0.8   | 1    | mA   | Bipolar current output mode  |
|  |       | 2.3   | 3    | mA   | Unipolar current output mode   |
| Power Dissipation                      |       |       |      |      | Power dissipation assuming an ideal power<br>supply and excluding external load power<br>dissipation, current output DPC mode, 0 mA to<br>20 mA range; see the Example Module Power<br>Calculation section for calculation methodology   |
|  |       | 100   |      | mW   | $\begin{array}{l} AV_{DD1}=24~V,~AV_{DD2}=5~V,~AV_{SS}=-15~V,~R_{LOAD}=\\ 1~k\Omega,~I_{OUT}=20~mA \end{array}$  |
|  |       | 145   |      | mW   | $\begin{array}{l} AV_{DD1}=24~V,~AV_{DD2}=5~V,~AV_{SS}=-15~V,~R_{LOAD}=\\ 0~\Omega,~I_{OUT}=20~mA \end{array}$   |
|  |       | 155   |      | mW   | $      AV_{DD1} = AV_{DD2} = 24 \ V, \ AV_{SS} = -15 \ V, \ R_{LOAD} = 1 \ k\Omega, \\      I_{OUT} = 20 \ mA $  |
|  |       | 200   |      | mW   | $      AV_{DD1} = AV_{DD2} = 24 \ V, \ AV_{SS} = -15 \ V, \ R_{LOAD} = 0 \ \Omega, \\      I_{OUT} = 20 \ mA $   |

<sup>1</sup> The long-term stability specification is noncumulative. The drift in subsequent 1000 hour periods is significantly lower than in the first 1000 hour period.
<sup>2</sup> Guaranteed by design and characterization; not production tested.
<sup>3</sup> See the Current Output section for more information about the internal and external R<sub>SET</sub> resistors.
<sup>4</sup> Production tested to AV<sub>DD1</sub> maximum = 30 V and AV<sub>SS</sub> minimum = -30 V.

#### AC PERFORMANCE CHARACTERISTICS

 $AV_{DD1} = V_{DPC+} = 15 \text{ V}$ ; dc-to-dc converter disabled;  $AV_{DD2} = 5 \text{ V}$ ;  $AV_{SS} = -15 \text{ V}$ ;  $V_{LOGIC} = 1.71 \text{ V}$  to 5.5 V; AGND = DGND = REFGND = PGND1 = 0 V; REFIN = 2.5 V external; voltage output:  $R_L = 1 \text{ k}\Omega$ ,  $C_L = 220 \text{ pF}$ ; current output:  $R_L = 300 \Omega$ ; all specifications at  $T_A = -40^{\circ}\text{C}$  to  $+115^{\circ}\text{C}$ , unless otherwise noted.

| Parameter                                   | Min | Тур | Max | Unit    | Test Conditions/Comments  |
|---|-----|-----|-----|---------|---|
| DYNAMIC PERFORMANCE <sup>1</sup>            |     |     |     |         |   |
| Voltage Output                              |     |     |     |         |   |
| Output Voltage Settling Time                |     |     |     |         | Output voltage settling time specifications also apply for dc-<br>to-dc converter enabled   |
|   |     | 6   | 20  | μs      | 5 V step to $\pm 0.03\%$ FSR, 0 V to 5 V range  |
|   |     | 12  | 20  | μs      | 10 V step to $\pm$ 0.03% FSR, 0 V to 10 V range   |
|   |     |     | 15  | μs      | 100 mV step to 1 LSB (16-bit LSB), 0 V to 10 V range  |
| Slew Rate                                   |     | 3   |     | V/µs    | 0 V to 10 V range, digital slew rate control disabled   |
| Power-On Glitch Energy                      |     | 25  |     | nV-sec  |   |
| Digital-to-Analog Glitch Energy             |     | 3   |     | nV-sec  |   |
| Glitch Impulse Peak Amplitude               |     | 25  |     | mV      |   |
| Digital Feedthrough                         |     | 2   |     | nV-sec  |   |
| Output Noise (0.1 Hz to 10 Hz<br>Bandwidth) |     | 0.2 |     | LSB p-p | 16-bit LSB, 0 V to 10 V range   |
| Output Noise Spectral Density               |     | 185 |     | nV/√Hz  | Measured at 10 kHz, midscale output, 0 V to 10 V range  |
| AC PSRR                                     |     | 70  |     | dB      | 200 mV, 50 Hz/60 Hz sine wave superimposed on power supply voltage  |
| Current Output                              |     |     |     |         |   |
| Output Current Settling Time                |     |     |     |         |   |
|   |     | 15  |     | μs      | To 0.1% FSR (0 mA to 24 mA), dc-to-dc converter disabled  |
|   |     | 15  |     | μs      | PPC mode, dc-to-dc converter enabled, dc-to-dc current limit = 150 mA   |
|   |     | 200 |     | μs      | DPC mode, dc-to-dc converter enabled; external inductor and capacitor components as described in Table 10, dc-to-dc current limit = 150 mA. |
| Output Noise (0.1 Hz to 10 Hz<br>Bandwidth) |     | 0.2 |     | LSB p-p | 16-bit LSB, 0 mA to 24 mA range   |
| Output Noise Spectral Density               |     | 0.8 |     | nA/√Hz  | Measured at 10 kHz, midscale output, 0 mA to 24 mA range  |
| AC PSRR                                     |     | 80  |     | dB      | 200 mV, 50 Hz/60 Hz sine wave superimposed on power supply voltage  |

<sup>1</sup> Guaranteed by design and characterization; not production tested.

#### TIMING CHARACTERISTICS

 $AV_{DD1} = V_{DPC+} = 15 \text{ V}; \text{ dc-to-dc converter disabled}; AV_{DD2} = 5 \text{ V}; AV_{SS} = -15 \text{ V}; V_{LOGIC} = 1.71 \text{ V to } 5.5 \text{ V}; AGND = DGND = REGND = PGND1 = 0 \text{ V}; REFIN = 2.5 \text{ V} \text{ external}; voltage output: R<sub>L</sub> = 1 k\Omega, C<sub>L</sub> = 220 pF; current output: R<sub>L</sub> = 300 <math>\Omega$ ; all specifications at T<sub>A</sub> = -40°C to +115°C, unless otherwise noted.

| Parameter <sup>1, 2, 3</sup> | $1.71~V \le V_{\text{LOGIC}} < 3~V$ | $3 V \le V_{LOGIC} \le 5.5 V$ | Unit        | Description   |
|------------------------------|-------------------------------------|-------------------------------|-------------|---|
| t1                           | 33                                  | 20                            | ns min      | SCLK cycle time, write operation  |
|                              | 120                                 | 66                            | ns min      | SCLK cycle time, read operation   |
| t <sub>2</sub>               | 16                                  | 10                            | ns min      | SCLK high time, write operation   |
|                              | 60                                  | 33                            | ns min      | SCLK high time, read operation  |
| t <sub>3</sub>               | 16                                  | 10                            | ns min      | SCLK low time, write operation  |
|                              | 60                                  | 33                            | ns min      | SCLK low time, read operation   |
| t4                           | 10                                  | 10                            | ns min      | SYNC falling edge to SCLK falling edge setup time, write  |
|                              |                                     |                               |             | operation   |
|                              | 33                                  | 33                            | ns min      | SYNC falling edge to SCLK falling edge setup time, read   |
|                              |                                     |                               |             | operation   |
| t₅                           | 10                                  | 10                            | ns min      | 24 <sup>th</sup> /32 <sup>nd</sup> SCLK falling edge to SYNC rising edge                          |
| t <sub>6</sub>               | 500                                 | 500                           | ns min      | SYNC high time (all register writes outside of those listed                                       |
|                              |                                     |                               |             | in this table)  |
|                              | 1.5                                 | 1.5                           | µs min      | SYNC high time (DAC_INPUT register write)   |
|                              | 500                                 | 500                           | µs min      | SYNC high time (DAC_CONFIG register write, where the  |
|                              |                                     |                               |             | Range[3:0] bits change; see the Calibration Memory CRC section)                                   |
| t7                           | 5                                   | 5                             | ns min      | Data setup time   |
| t <sub>8</sub>               | 6                                   | 6                             | ns min      | Data hold time  |
| t9                           | 750                                 | 750                           | ns min      | LDAC falling edge to SYNC rising edge   |
| t <sub>10</sub>              | 1.5                                 | 1.5                           | µs min      | SYNC rising edge to LDAC falling edge   |
| t <sub>11</sub>              | 250                                 | 250                           | ns min      | LDAC pulse width low  |
| t <sub>12</sub>              | 600                                 | 600                           | ns max      | LDAC falling edge to DAC output response time, digital  |
|                              |                                     |                               |             | slew rate control disabled.   |
|                              | 2                                   | 2                             | µs max      | LDAC falling edge to DAC output response time, digital  |
|                              |                                     |                               |             | slew rate control enabled.  |
| t <sub>13</sub>              | See the AC Performance              | e Characteristics section     | µs max      | DAC output settling time  |
| t <sub>14</sub>              | 1.5                                 | 1.5                           | μs max      | $\overline{\text{SYNC}}$ rising edge to DAC output response time ( $\overline{\text{LDAC}} = 0$ ) |
| <b>t</b> 15                  | 5                                   | 5                             | µs min      | RESET pulse width   |
| t <sub>16</sub>              | 40                                  | 28                            | '<br>ns max | SCLK rising edge to SDO valid   |
| t <sub>17</sub>              | 100                                 | 100                           | µs min      | RESET rising edge to 1 <sup>st</sup> SCLK falling edge after SYNC                                 |
|                              |                                     |                               |             | falling edge ( $t_{17}$ does not appear in the timing diagrams)                                   |

Table 3.

<sup>1</sup> Guaranteed by design and characterization; not production tested.

 $^{2}$  All input signals are specified with  $t_{R} = t_{F} = 5$  ns (10% to 90% of V<sub>LOGIC</sub>) and timed from a voltage level of 1.2 V.  $t_{R}$  is rise time.  $t_{F}$  is fall time.

<sup>3</sup> See Figure 2, Figure 3, Figure 4, and Figure 5.

#### **Timing Diagrams**



Figure 3. Readback Timing Diagram



<sup>1</sup>IF ANY EXTRA SCLK FALLING EDGES ARE RECEIVED AFTER THE 24<sup>TH</sup> (OR 32<sup>ND</sup>, IF CRC IS ENABLED) SCLK, BEFORE SYNC RETURNS HIGH, SDO CLOCKS OUT 0. Figure 4. Autostatus Readback Timing Diagram



Figure 5. Load Circuit for SDO Timing Diagram

### **Data Sheet**

### **ABSOLUTE MAXIMUM RATINGS**

 $T_A = 25^{\circ}$ C, unless otherwise noted. Transient currents of up to 100 mA do not cause silicon controlled rectifier (SCR) latch-up.

#### Table 4.

| Parameter   | Rating  |
|---|---|
| AV <sub>DD1</sub> to AGND, DGND   | –0.3 V to +44 V   |
| AVss to AGND, DGND  | +0.3 V to -33 V   |
| AV <sub>DD1</sub> to AV <sub>SS</sub>   | –0.3 V to +66 V   |
| AVDD2, VDPC+ to AGND, DGND  | –0.3 V to +35 V   |
| AV <sub>DD2</sub> , V <sub>DPC+</sub> to AV <sub>SS</sub>                     | –0.3 V to +55 V   |
| VLOGIC to DGND  | –0.3 V to +7 V  |
| Digital Inputs to DGND ( <u>SCLK,</u><br>SDI, SYNC, AD0, AD1, RESET,<br>LDAC) | -0.3 V to V <sub>LOGIC</sub> + 0.3 V or +7 V<br>(whichever is less) |
| Digital Outputs to DGND (FAULT,<br>SDO, CLKOUT)                               | -0.3 V to V <sub>LOGIC</sub> + 0.3 V or +7 V (whichever is less)    |
| REFIN, REFOUT, VLDO, CHART TO<br>AGND   | -0.3 V to AV <sub>DD2</sub> + 0.3 V or +7 V<br>(whichever is less)  |
| R <sub>A</sub> to AGND  | –0.3 V to +4.5 V  |
| R <sub>B</sub> to AGND  | –0.3 V to +4.5 V  |
| VIout to AGND   | ±35 V   |
| VIOUT_INT to AGND   | ±35 V   |
| +V <sub>SENSE</sub> to AGND   | ±35 V   |
| -VSENSE tO AGND   | ±35 V   |
| CCOMP to AGND   | $AV_{SS} - 0.3 V$ to $V_{DPC+} + 0.3 V$                             |
| SW+ to AGND   | -0.3 V to AV <sub>DD1</sub> + 0.3 V or +33 V<br>(whichever is less) |
| AGND, DGND to REFGND  | –0.3 V to +0.3 V  |
| AGND, DGND to PGND1   | –0.3 V to +0.3 V  |
| Industrial Operating Temperature<br>Range (T <sub>A</sub> ) <sup>1</sup>      | –40°C to +115°C   |
| Storage Temperature Range   | –65°C to +150°C   |
| Junction Temperature (TJ max)   | 125°C   |
| Power Dissipation   | (T」 maximum – T <sub>A</sub> )/θ <sub>JA</sub>                      |
| Lead Temperature  | JEDEC industry standard   |
| Soldering   | J-STD-020   |

<sup>1</sup> Power dissipated on the chip must be derated to keep the junction temperature below 125°C.

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

#### THERMAL RESISTANCE

Thermal performance is directly linked to printed circuit board (PCB) design and operating environment. Close attention to PCB thermal design is required.

#### Table 5. Thermal Resistance

| Package Type          | Αιθ | οις | Unit |
|-----------------------|-----|-----|------|
| CP-32-30 <sup>1</sup> | 46  | 18  | °C/W |

<sup>1</sup> Test Condition 1: thermal impedance simulated values are based on a JEDEC 2S2P thermal test board with thermal vias. See JEDEC JESD51.

#### **ESD CAUTION**



**ESD** (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

### **PIN CONFIGURATION AND FUNCTION DESCRIPTIONS**



#### **Table 6. Pin Function Descriptions**

| Pin No. | Mnemonic          | Description  |  |  |  |
|---------|-------------------|--|--|--|--|
| 1       | SW+               | Switching Output for the DC-to-DC Circuitry. To use the dc-to-dc feature of the device, connect as shown in Figure 77.   |  |  |  |
| 2       | AV <sub>DD1</sub> | Positive Analog Supply. The voltage range is from 7 V to 33 V.   |  |  |  |
| 3       | AV <sub>DD2</sub> | Positive Low Voltage Analog Supply. The voltage range is from 5 V to 33 V.   |  |  |  |
| 4       | NIC               | Not Internally Connected. This pin is not internally connected.  |  |  |  |
| 5       | AGND              | Ground Reference Point for the Analog Circuitry. This pin must be connected to 0 V.  |  |  |  |
| 6       | REFGND            | Ground Reference Point for Internal Reference. This pin must be connected to 0 V.  |  |  |  |
| 7       | RA                | External Current Setting Resistor. An external, precision, low drift 13.7 kΩ current setting resistor can be connected between R <sub>A</sub> and R <sub>B</sub> to improve the current output temperature drift performance. It is recommended that the external resistor be placed as close as possible to the AD5758. |  |  |  |
| 8       | R <sub>B</sub>    | External Current Setting Resistor. An external, precision, low drift 13.7 kΩ current setting resistor can be connected between R <sub>A</sub> and R <sub>B</sub> to improve the current output temperature drift performance. It is recommended that the external resistor be placed as close as possible to the AD5758. |  |  |  |
| 9       | REFIN             | External 2.5 V Reference Voltage Input.  |  |  |  |
| 10      | REFOUT            | Internal 2.5 V Reference Voltage Output. REFOUT must be connected to REFIN to use the internal reference. A capacitor between REFOUT and REFGND is not recommended.  |  |  |  |
| 11      | C <sub>HART</sub> | HART Input Connection. The HART signal must be ac-coupled to this pin. If HART is not being used, leave this pin<br>unconnected. This pin is disconnected from the HART summing node by default and can be connected via the<br>HART_EN bit in the GP_CONFIG1 register.  |  |  |  |
| 12      | VLDO              | 3.3 V LDO Output Voltage. V <sub>LDO</sub> must be decoupled to AGND with a 0.1 $\mu$ F capacitor.   |  |  |  |
| 13      | VLOGIC            | Digital Supply. The voltage range is from 1.71 V to 5.5 V. V <sub>LOGIC</sub> must be decoupled to DGND with a 0.1 $\mu$ F capacitor.  |  |  |  |
| 14      | SDO               | Serial Data Output. This pin clocks data from the serial register in readback mode. The maximum SCLK speed for readback mode is 15 MHz (depending on the $V_{LOGIC}$ voltage). See Table 3.  |  |  |  |
| 15      | DGND              | Digital Ground.  |  |  |  |
| 16      | RESET             | Hardware <u>Reset</u> . Active low input. Do not write an SPI command within 100 µs of issuing a reset (using the hardware RESET pin or via software).   |  |  |  |
| 17      | LDAC              | Load DAC. Active low input. This pin updates the DAC_OUTPUT register and, consequently, the DAC output. Do not assert LDAC within the window of 500 ns before the rising edge of SYNC or 1.5 µs after the rising edge of SYNC (see Table 3 for the timing specifications).   |  |  |  |
| 18      | CLKOUT            | Optional Clock Output Signal (Disabled by Default). This pin is a divided down version of the internal 10 MHz oscillator (MCLK) and is configured in the GP_CONFIG1 register.  |  |  |  |

| Pin No. | Mnemonic              | Description   |  |  |
|---------|-----------------------|---|--|--|
| 19      | SCLK                  | Serial Clock Input. Data is clocked into the input shift register on the falling edge of SCLK. In write mode, this pin operates at clock speeds of up to 50 MHz (depending on the VLOGIC voltage). In read mode, the maximum SCLK speed is 15 MHz (depending on the VLOGIC voltage). See Table 3 for the timing specifications.   |  |  |
| 20      | SDI                   | Serial Data Input. Data must be valid on the falling edge of SCLK.  |  |  |
| 21      | SYNC                  | Frame Synchronization Signal for the Serial Interface. Active low input. While SYNC is low, data is transferred in on the falling edge of SCLK.   |  |  |
| 22      | AD1                   | Address Decode 1 for the DUT on the Board.  |  |  |
| 23      | AD0                   | Address Decode 0 for the DUT on the Board.  |  |  |
| 24      | FAULT                 | Fault Pin. Active low, open-drain output. This pin is high impedance when no faults are detected and is asserted low when certain faults are detected, for example, an open circuit in current mode, a short circuit in voltage mode a CRC error, or an overtemperature error (see the Output Fault section). This pin must be connected to V <sub>LOGIC</sub> with a 10 kC pull-up resistor.   |  |  |
| 25      | AVss                  | Negative Analog Supply. The voltage range is from 0 V to $-33$ V. If using the device solely for unipolar current output purposes, AV <sub>SS</sub> can be 0 V. For a unipolar voltage output, AV <sub>SS</sub> (maximum) is $-2.5$ V. When using bipolar output ranges, V <sub>0UT</sub> /I <sub>0UT</sub> headroom must be obeyed when calculating the AV <sub>SS</sub> maximum, for example, for a $\pm 10$ V output, the AV <sub>SS</sub> maximum is $-12.5$ V. See the AVSS Considerations section for an important note on power supply sequencing. |  |  |
| 26      | -V <sub>SENSE</sub>   | Sense Connection for the Negative Voltage Output Load Connection for $V_{OUT}$ Mode. This pin must stay within ±10 <sup>1</sup> of AGND for specified operation. For specified operation, AV <sub>SS</sub> tracks $-V_{SENSE}$ with respect to AGND. If remote sensing is not being used, short this pin to AGND.   |  |  |
| 27      | Ссомр                 | Optional Compensation Capacitor Connection for the Voltage Output Buffer. Connecting a 220 pF capacitor between this pin and the Vlout pin allows the voltage output to drive up to 2 µF. The addition of this capacitor reduces the bandwidth of the output amplifier, increasing the settling time.   |  |  |
| 28      | +V <sub>SENSE</sub>   | Sense Connection for the Positive Voltage Output Load Connection for Voltage Output Mode. If remote sensing is not being used, short this pin to Vlout via a series 1 k $\Omega$ resistor.  |  |  |
| 29      | VIOUT                 | Voltage/Current Output Pin. Vlout is a shared pin, providing either a buffered output voltage or current.   |  |  |
| 30      | VI <sub>OUT_INT</sub> | Fault Protect Switch Internal Node. The inside of the fault protect switch is routed to this pin.   |  |  |
| 31      | V <sub>DPC+</sub>     | Positive Supply for Current and Voltage Output Stage. To use the dc-to-dc feature of the device, connect as shown in Figure 77.   |  |  |
| 32      | PGND1                 | Power Ground.   |  |  |
|         | EPAD                  | Exposed Pad. Connect the exposed pad to the potential of the AV <sub>ss</sub> pin, or, alternatively, it can be left electrically unconnected. It is recommended that the pad be thermally connected to a copper plane for enhanced thermal performance.  |  |  |

## **TYPICAL PERFORMANCE CHARACTERISTICS**



Figure 7. INL Error vs. DAC Code









### **Data Sheet**











Figure 27. VOUT vs. Time on Output Enable



Figure 28. VOUT vs. Time on Power-Up





11840-240

240-242

11840-236

125

125



Figure 33. Total Unadjusted Error vs. DAC Code

Figure 36. DNL vs. Temperature













Figure 40. Full-Scale Error vs. Temperature





### **Data Sheet**



Figure 43. Total Unadjusted Error vs. AVDD1/AVss Supply, Internal Rset



Figure 44. Total Unadjusted Error vs. AV<sub>DD1</sub>/|AV<sub>SS</sub>| Supply, External R<sub>SET</sub>

















Figure 49. Output Current vs. Time on Power-Up



Figure 50. Output Current vs. Time on Output Enable



Figure 51. DC-to-DC Converter Headroom vs. Output Current



Figure 52. Output Current and V<sub>DPC+</sub> Settling Time

### **Data Sheet**

### 

*Figure 53. Output Current and V*<sub>DPC+</sub> *Settling Time vs. Temperature* 



Figure 54. Output Current Ripple vs. Time with DC-to-DC Converter



#### DC-TO-DC BLOCK







20

10

° °

2 4 6 8 10 12 14 16 18 20 22 24

1840-284

#### REFERENCE



Figure 62. REFOUT Turn On Transient



Figure 63. Peak-to-Peak Noise (0.1 Hz to 10 Hz Bandwidth)



Figure 64. Peak-to-Peak Noise (100 kHz Bandwidth)





11840-272

#### GENERAL



Figure 68. VLOGIC Current vs. Logic Input Voltage









Figure 71. Fault Protect Switch On Resistance vs. VIOUT Bias Sweep







### TERMINOLOGY

#### Total Unadjusted Error (TUE)

TUE is a measure of the output error taking all the various errors into account, namely INL error, offset error, gain error, and output drift over supplies, temperature, and time. TUE is expressed in % FSR.

#### Relative Accuracy or Integral Nonlinearity (INL)

For the DAC, relative accuracy, or INL, is a measure of the maximum deviation, in LSBs or % FSR, from the best fit line passing through the DAC transfer function.

#### Differential Nonlinearity (DNL)

DNL is the difference between the measured change and the ideal 1 LSB change between any two adjacent codes. A specified differential nonlinearity of  $\pm 1$  LSB maximum ensures monotonicity. This DAC is guaranteed monotonic by design.

#### Monotonicity

A DAC is monotonic if the output either increases or remains constant for increasing digital input code. The AD5758 is monotonic over its full operating temperature range.

#### Zero-Scale/Negative Full-Scale Error

Zero-scale/negative full-scale error is the error in the DAC output voltage when 0x0000 (straight binary coding) is loaded to the DAC output register.

#### Zero-Scale Temperature Coefficient (TC)

Zero-scale TC is a measure of the change in zero-scale error with a change in temperature. Zero-scale error TC is expressed in ppm FSR/°C.

#### **Bipolar Zero Error**

Bipolar zero error is the deviation of the analog output from the ideal half-scale output of 0 V when the DAC output register is loaded with 0x8000 (straight binary coding).

#### **Bipolar Zero Temperature Coefficient (TC)**

Bipolar zero TC is a measure of the change in the bipolar zero error with a change in temperature. It is expressed in ppm FSR/°C.

#### **Offset Error**

Offset error is the deviation of the analog output from the ideal and is measured using ¼ scale and ¾ scale digital code measurements. It is expressed in % FSR.

#### Offset Error (TC)

Offset error TC is a measure of the change in the offset error with a change in temperature. It is expressed in ppm FSR/°C.

#### **Gain Error**

Gain error is a measure of the span error of the DAC. It is the deviation in slope of the DAC transfer characteristic from the ideal expressed in % FSR.

#### Gain Error Temperature Coefficient (TC)

Gain error TC is a measure of the change in gain error with changes in temperature. Gain error TC is expressed in ppm FSR/°C.

#### **Full-Scale Error**

Full-scale error is a measure of the output error when full-scale code is loaded to the DAC output register. Ideally, the output is full-scale -1 LSB. Full-scale error is expressed in % FSR.

#### Headroom

This is the difference between the voltage required at the output (programmed voltage in voltage output mode and programmed current  $\times$  R<sub>LOAD</sub> in current output mode) and the voltage supplied by the positive supply rail, V<sub>DPC+</sub>. Headroom is relevant when the output is positive with respect to ground.

#### Footroom

Footroom is the difference between the voltage required at the output (programmed voltage in voltage output mode and programmed current  $\times$  R<sub>LOAD</sub> in current output mode) and the voltage supplied by the negative supply rail, AV<sub>SS</sub>. Footroom is relevant when the output is negative with respect to ground.

#### Vout/-Vsense Common-Mode Rejection Ratio (CMRR)

 $V_{\text{OUT}}/-V_{\text{SENSE}}$  CMRR is the error in  $V_{\text{OUT}}$  voltage due to changes in  $-V_{\text{SENSE}}$  voltage.

#### **Current Loop Compliance Voltage**

The maximum voltage at the  $\rm VI_{\rm OUT}$  pin for which the output current is equal to the programmed value.

#### Voltage Reference TC

Voltage reference TC is a measure of the change in the reference output voltage with a change in temperature. The reference TC is calculated using the box method, which defines the TC as the maximum change in the reference output over a given temperature range expressed in ppm/°C, as follows:

$$TC = \left(\frac{V_{REF\_MAX} - V_{REF\_MIN}}{V_{REF\_NOM} \times TempRange}\right) \times 10^{6}$$

where:

 $V_{REF\_MAX}$  is the maximum reference output measured over the total temperature range.

 $V_{\it REF\_MIN}$  is the minimum reference output measured over the total temperature range.

 $V_{REF_NOM}$  is the nominal reference output voltage, 2.5 V. *TempRange* is the specified temperature range, -40°C to +115°C.

#### Line Regulation

Line regulation is the change in reference output voltage due to a specified change in power supply voltage. It is expressed in ppm/V.

#### Load Regulation

Load regulation is the change in reference output voltage due to a specified change in reference load current. It is expressed in ppm/mA.

#### **Dynamic Power Control (DPC)**

In this mode, the AD5758 circuitry senses the output voltage and dynamically regulates the supply voltage,  $V_{\rm DPC+}$ , to meet compliance requirements plus an optimized headroom voltage for the output buffer.

#### Programmable Power Control (PPC)

In this mode, the  $V_{\rm DPC+}$  voltage is user-programmable to a fixed level that needs to accommodate the maximum output load required.

#### **Output Voltage Settling Time**

Output voltage settling time is the amount of time it takes for the output to settle to a specified level for a full-scale input change. This specification depends on the manner in which the DPC feature is configured (enabled, disabled, PPC mode enabled) and on the characteristics of the external dc-to-dc inductor and capacitor components used.

#### Slew Rate

The slew rate of a device is a limitation in the rate of change of the output voltage. The output slewing speed of a voltage output DAC is usually limited by the slew rate of the amplifier used at its output. Slew rate is measured from 10% to 90% of the output signal and is expressed in  $V/\mu s$ .

#### **Power-On Glitch Energy**

Power-on glitch energy is the impulse injected into the analog output when the AD5758 is powered on. It is specified as the area of the glitch in nV-sec.

#### Digital-to-Analog Glitch Energy

Digital-to-analog glitch energy is the energy of the impulse injected into the analog output when the input code in the DAC output register changes state. It is normally specified as the area of the glitch in nV-sec. Worst case is usually when the digital input code is changed by 1 LSB at the major carry transition (0x7FFF to 0x8000).

#### **Glitch Impulse Peak Amplitude**

Glitch impulse peak amplitude is the peak amplitude of the impulse injected into the analog output when the input code in the DAC output register changes state. It is specified as the amplitude of the glitch in millivolts and the worst case is usually when the digital input code is changed by 1 LSB at the major carry transition (0x7FFF to 0x8000).

#### **Digital Feedthrough**

Digital feedthrough is a measure of the impulse injected into the analog output of the DAC from the digital inputs of the DAC but is measured when the DAC output is not updated ( $\overline{\text{LDAC}}$  pin is held high). It is specified in nV-sec and measured with a full-scale code change on the data bus.

#### Power Supply Rejection Ratio (PSRR)

PSRR indicates how the output of the DAC is affected by changes in the power supply voltage.

### THEORY OF OPERATION

The AD5758 is a single-channel, precision voltage and current output DAC, designed to meet the requirements of industrial factory automation and process control applications. It provides a high precision, fully integrated, single-chip solution for generating a unipolar/bipolar current or voltage output. Package power dissipation is minimized by incorporating on-chip DPC, which is achieved by regulating the supply voltage ( $V_{DPC+}$ ) to the  $VI_{OUT}$  output driver from 4.95 V to 27 V using a buck dc-to-dc converter, optimized for minimum on-chip power dissipation. The AD5758 consists of a two die solution with the dc-to-dc converter circuitry and the  $VI_{OUT}$  fault protection switch located on the dc-to-dc die, and the remaining circuitry on the main die. Interdie communication is performed over an internal 3-wire interface.

#### DAC ARCHITECTURE

The DAC core architecture of the AD5758 consists of a voltage mode R-2R ladder network. The voltage output of the DAC core is either converted to a current or voltage output at the VI<sub>OUT</sub> pin. Only one mode can be enabled at any one time. Both the voltage and current output stages are supplied by the  $V_{DPC+}$  power rail (internally generated from AV<sub>DD1</sub>) and the AV<sub>SS</sub> rail.

#### **Current Output Mode**

If current output mode is enabled, the voltage output from the DAC is converted to a current (see Figure 74), which is then mirrored to the supply rail so that the application only sees a current source output.

The current ranges available are 0 mA to 20 mA, 0 mA to 24 mA, 4 mA to 20 mA,  $\pm 20$  mA,  $\pm 24$  mA, and -1 mA to  $\pm 22$  mA. An internal or external 13.7 k $\Omega$  R<sub>SET</sub> resistor can be used for the voltage to current conversion.



Figure 74. Voltage to Current Conversion Circuitry

#### Voltage Output Mode

If voltage output mode is enabled, the voltage output from the DAC is buffered and scaled to output a software-selectable unipolar or bipolar voltage range (see Figure 75).

The voltage ranges available are 0 V to 5 V,  $\pm$ 5 V, 0 V to 10 V, and  $\pm$ 10 V. A 20% overrange feature is also available via the DAC\_ CONFIG register, as well as the facility to negatively offset the unipolar voltage ranges via the GP\_CONFIG1 register (see the General-Purpose Configuration 1 Register section).



Figure 75. Voltage Output

#### Reference

The AD5758 can operate with either an external or internal reference. The reference input requires a 2.5 V reference for specified performance. This input voltage is then internally buffered before it is applied to the DAC.

The AD5758 contains an integrated buffered 2.5 V voltage reference that is externally available for use elsewhere within the system. The internal reference drives the integrated 12-bit ADC. REFOUT must be connected to REFIN to use the internal reference to drive the DAC.

#### SERIAL INTERFACE

The AD5758 is controlled over a versatile 4-wire serial interface that operates at clock rates of up to 50 MHz and is compatible with SPI, QSPI, MICROWIRE, and DSP standards. Data coding is always straight binary.

#### Input Shift Register

With SPI CRC enabled (default state), the input shift register is 32 bits wide. Data is loaded into the device MSB first as a 32-bit word under the control of a serial clock input, SCLK. Data is clocked in on the falling edge of SCLK. If CRC is disabled, the serial interface is reduced to 24 bits; a 32-bit frame is still accepted but the last 8 bits are ignored. See the Register Map section for full details on the registers that can be addressed via the SPI interface.

#### Table 7. Writing to a Register (CRC enabled)

| MSB      |                |                     |          | LSB     |
|----------|----------------|---------------------|----------|---------|
| D31      | [D30:D29]      | [D28:D24]           | [D23:D8] | [D7:D0] |
| Slip Bit | DUT<br>address | Register<br>address | Data     | CRC     |

#### **Transfer Function**

Table 8 shows the input code to ideal output voltage relationship for the AD5758 for straight binary data coding of the  $\pm 5$  V output range.

| Table 8. Ideal Outpu | t Voltage to Input | Code Relationship |
|----------------------|--------------------|-------------------|
|----------------------|--------------------|-------------------|

| Digital Input, Straight Binary<br>Data Coding |      |      |      | Analog Output                         |
|---|------|------|------|---------------------------------------|
| MSB   |      | L    | SB   | Vout                                  |
| 1111  | 1111 | 1111 | 1111 | +2 V <sub>REF</sub> × (32,767/32,768) |
| 1111  | 1111 | 1111 | 1110 | $+2 V_{REF} \times (32,766/32,768)$   |
| 1000  | 0000 | 0000 | 0000 | 0 V                                   |
| 0000  | 0000 | 0000 | 0001 | $-2 V_{REF} \times (32,767/32,768)$   |
| 0000  | 0000 | 0000 | 0000 | -2 V <sub>REF</sub>                   |

#### **POWER-ON STATE OF THE AD5758**

On initial power-on or a device reset of the AD5758, the voltage and current output channels are disabled. The VI<sub>OUT</sub> fault protection switch is open, as is the switch connecting VI<sub>OUT</sub> via a 30 k $\Omega$  pull-down resistor to AGND. Both of these switches can be enabled via the DCDC\_CONFIG1 register and the DCDC\_ CONFIG2 register, respectively. V<sub>DPC+</sub> is internally driven to 4.8 V on power-on, until the dc-to-dc converter is enabled.

After device power-on, or a device reset, a calibration memory refresh command is required (see the Programming Sequence to Enable the Output section). It is recommended to wait 500  $\mu$ s minimum after writing this command, before writing further instructions to the device to allow time for internal calibrations to take place (see Figure 92).

#### Power-On Reset



Figure 76. Power-On Reset Block Diagram

The AD5758 incorporates a power-on reset circuit that ensures the AD5758 is held in reset while the power supplies are at a level insufficient to allow reliable operation. The power-on reset circuit (see Figure 76) monitors the  $AV_{DD2}$  generated  $V_{LD0}$  and INT\_AVCC voltages, the RESET pin, and the SPI reset signal. The power-on reset circuit keeps the AD5758 in reset until the voltages on the  $V_{LD0}$  and INT\_AVCC nodes are sufficient for reliable operation. If the power-on circuit receives a signal from the RESET pin, or if a software reset is written to the AD5758 via the SPI interface, the AD5758 is reset. Do not write SPI commands to the device within 100 µs of a reset event.

#### **POWER SUPPLY CONSIDERATIONS**

The AD5758 has four supply rails:  $AV_{DD1}$ ,  $AV_{DD2}$ ,  $AV_{SS}$ , and  $V_{LOGIC}$ . See Table 1 for the voltage range of the four supply rails and the associated conditions.

#### **AV**<sub>DD1</sub> Considerations

 $AV_{DD1}$  is the supply rail for the dc-to-dc converter and can range from 7 V to 33 V. Although the maximum value of  $AV_{DD1}$  is 33 V and the minimum value of  $AV_{SS}$  is –33 V, the maximum operating range of  $|AV_{DD1}$  to  $AV_{SS}|$  is 60 V.  $V_{DPC+}$  is derived from  $AV_{DD1}$ , and its value depends on the mode of operation of the dc-to-dc converter.

The dc-to-dc converter requires a sufficient level of margin to be maintained between  $AV_{DD1}$  and  $V_{DPC+}$  to ensure the dc-to-dc circuitry operates correctly. This margin is 5% of the maximum  $V_{DPC+}$  voltage for a given mode of operation.

Table 9. AV<sub>DD1</sub> to V<sub>DPC+</sub> Margin

| Mode of Operation | V <sub>DPC+</sub> Maximum              |
|-------------------|--|
| DPC Voltage Mode  | 15 V                                   |
| DPC Current Mode  | (Iout maximum × RLOAD) + Iout headroom |
| PPC Current Mode  | DCDC_CONFIG1[4:0] programmed value     |

See the Power Dissipation Control section for further details on the dc-to-dc converter modes of operation.

Assuming DPC current mode,

- $I_{OUT}$  maximum = 20 mA;  $R_{LOAD}$  = 1 k $\Omega$
- $I_{OUT}$  headroom = 2.5 V
- V<sub>DPC+</sub> maximum = 20 V + 2.5 V = 22.5 V

$$\begin{split} &|V_{DPC+} \text{ to } AV_{DD1}| \text{ headroom can be calculated as 5% of } 22.5 \text{ V} = \\ &1.125 \text{ V}. \text{ Therefore, } AV_{DD1} \text{ (minimum)} = 22.5 \text{ V} + 1.125 \text{ V} = \\ &23.625 \text{ V}. \text{ Assuming a worst case } AV_{DD1} \text{ supply rail tolerance of } \\ &\pm 10\%, \text{ this example requires an } AV_{DD1} \text{ supply rail of } \\ &\text{approximately } 26.25 \text{ V}. \end{split}$$

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#### **AV**ss Considerations

AV<sub>SS</sub> is the negative supply rail and has a range of -33 V to 0 V. As in the case of AV<sub>DD1</sub>, AV<sub>SS</sub> must obey the maximum operating range of  $|AV_{DD1}$  to AV<sub>SS</sub>| of 60 V. For bipolar current output ranges, the maximum AV<sub>SS</sub> can be calculated as (I<sub>OUT\_MAX</sub> × R<sub>LOAD</sub>) + I<sub>OUT</sub> footroom. For unipolar current output ranges, AV<sub>SS</sub> can be tied to AGND (that is, 0 V). For unipolar voltage output ranges, the maximum AV<sub>SS</sub> is -2.5 V to enable sufficient footroom for the internal voltage output circuitry. To avoid power supply sequencing issues, a Schottky diode must be placed between AV<sub>SS</sub> and GND (the GND supply must always be available).

#### AV<sub>DD2</sub> Considerations

 $AV_{\rm DD2}$  is the positive low voltage supply rail and has a range of 5 V to 33 V. If only one positive power rail is available,  $AV_{\rm DD2}$  can be tied to  $AV_{\rm DD1}$ . However, to optimize for reduced power dissipation, supply  $AV_{\rm DD2}$  with a separate lower voltage supply.

#### **V**LOGIC Considerations

 $V_{\rm LOGIC}$  is the digital supply for the device and can range from 1.71 V to 5.5 V. The 3.3 V  $V_{\rm LDO}$  output voltage can be used to drive  $V_{\rm LOGIC}$ .

### **DEVICE FEATURES AND DIAGNOSTICS** POWER DISSIPATION CONTROL

The AD5758 contains integrated buck dc-to-dc converter circuitry that controls the power supply to the output buffers, allowing a reduction in power consumption from standard designs when using the device in both current and voltage output modes.  $AV_{DD1}$  is the supply rail for the dc-to-dc converter and ranges from 7 V to 33 V.  $V_{DPC+}$  is derived from this rail and its value depends on the mode of operation of the dc-to-dc converter, as well as the output load, including DPC voltage mode, DPC current mode, and PPC current mode

Figure 77 shows the discrete components needed for the dc-todc circuitry and the following sections describe component selection and operation of this circuitry.



Table 10. Recommended DC-to-DC Components

| Symbol | Component          | Value  | Manufacturer |  |
|--------|--------------------|--------|--------------|--|
| LDCDC  | PA6594-AE          | 47 µH  | Coilcraft    |  |
| CDCDC  | GRM31CR71H225KA88L | 2.2 μF | Murata       |  |
| CIN    | GRM31CR71H475KA12L | 4.7 μF | Murata       |  |

#### DC-to-DC Converter Operation

The dc-to-dc converter uses a fixed 500 kHz frequency, peak current mode control scheme to step down the AV<sub>DD1</sub> input to produce V<sub>DPC+</sub> to supply the driver circuitry of the voltage/current output channel. The dc-to-dc converter incorporates a low-side synchronous switch and, therefore, does not require an external Schottky diode. The dc-to-dc converter is designed to operate predominantly in discontinuous conduction mode (DCM), where the inductor current goes to zero for an appreciable percentage of the switching cycle. To avoid generating lower frequency harmonics on the V<sub>DPC+</sub> regulated output voltage rail, the dc-to-dc converter does not skip any cycles. Therefore, the dc-to-dc converter must transfer a minimum amount of energy to its load (that is, the current or voltage output stage and its respective load) to operate at a fixed frequency. Thus, for light loads (for example, low RLOAD or low IOUT), the VDPC+ voltage can rise beyond the target value and go out of regulation. This rise in voltage is not a fault condition and does not represent the worst case power dissipation condition in an application.

Note that the dc-to-dc converter requires a sufficient level of margin to be maintained between  $AV_{DD1}$  and  $V_{DPC+}$  to ensure

that the dc-to-dc circuitry operates correctly. This margin value is 5% of  $V_{\mbox{\tiny DPC+}}$  maximum.

#### DPC Voltage Mode

In DPC voltage mode, with the voltage output enabled or disabled, the converter regulates the V<sub>DPC+</sub> supply to 15 V above the  $-V_{\text{SENSE}}$  voltage. This mode allows the full output voltage range to be efficiently applied across remote loads, with corresponding remote grounds at up to ±10 V potential relative to the local ground supply (AGND) for the AD5758.

#### DPC Current Mode

In standard current input module designs, the combined line and load resistance values can range from typically 50  $\Omega$  to 750  $\Omega$ . Output module systems must provide enough voltage to meet the compliance voltage requirement across the full range of load resistor values. For example, in a 4 mA to 20 mA loop, when driving 20 mA into a 750  $\Omega$  load, a compliance voltage of >15 V is required. When driving 20 mA into a 50  $\Omega$  load, the required compliance is reduced to >1 V.

In DPC current mode, the AD5758 dc-to-dc circuitry senses the output voltage and regulates the  $V_{\rm DPC+}$  supply voltage to meet compliance requirements plus an optimized headroom voltage for the output buffer.  $V_{\rm DPC+}$  is dynamically regulated to 4.95 V or ( $I_{\rm OUT} \times R_{\rm LOAD}$  + headroom), whichever is greater, which excludes the light load condition whereby the  $V_{\rm DPC+}$  voltage can rise beyond the target value. As previously noted, this exclusion does not represent the worst case power dissipation condition in an application. The AD5758 is capable of driving up to 24 mA through a 1 k\Omega load, for a given input supply (24 V + headroom).

At low output power levels, the regulated headroom increases above 2.1 V due to the fact that the dc-to-dc circuitry uses a minimum on time duty cycle. This behaviour is expected and does not impact any worse case power dissipation.

#### **PPC Current Mode**

The dc-to-dc converter may also operate in programmable power control mode, where the  $V_{DPC+}$  voltage is user-programmable to a given level to accommodate the maximum output load required. This mode represents a trade-off between the optimized power efficiency of the DPC current mode and the settling time of a system with a fixed supply (dc-to-dc disabled). In PPC current mode,  $V_{DPC+}$  is regulated to a user-programmable level between 5.43 V and 28.48 V with respect to  $-V_{SENSE}$  (in steps of 0.743 V). See Table 18 for important information on the voltage step size. This mode is useful if settling time is an important requirement of the design. See the DC-to-DC Converter Settling Time section. Care is needed in selecting the programmed level of  $V_{DPC+}$  if the load is nonlinear in nature.  $V_{DPC+}$  must be set high enough to obey the output compliance voltage specification. If the load is unknown, the  $+V_{SENSE}$  input to the ADC can be used to monitor

the  $VI_{\text{OUT}}$  pin in current mode to determine the user-programmable value at which to set  $V_{\text{DPC+}}.$ 

#### DC-to-DC Converter Settling Time

When in DPC current mode, the settling time is dominated by the settling time of the dc-to-dc converter and is typically 200  $\mu$ s without the digital slew rate control feature enabled. To reduce initial VI<sub>OUT</sub> waveform overshoot without adding a capacitor on VI<sub>OUT</sub> and thereby affecting HART operation, enable the digital slew rate control feature using the DAC\_CONFIG register (see Table 33).

Table 11 shows the typical settling time for each of the dc-todc converter modes. All values shown assume the use of the components recommended by Analog Devices, Inc., listed in Table 10. The achievable settling time in any given application is dependent on the choice of external inductor and capacitor components used, as well as the current-limit setting of the dcto-dc converter.

#### Table 11. Settling Time vs. DC-to-DC Converter Mode

| DC-to-DC Converter Mode | Settling Time (µs) |
|-------------------------|--------------------|
| DPC Current Mode        | 200                |
| PPC Current Mode        | 15                 |
| DPC Voltage Mode        | 15                 |

#### DC-to-DC Converter Inductor Selection

For typical 4 mA to 20 mA applications, a 47  $\mu$ H inductor (per Table 10), combined with the switching frequency of 500 kHz, allows up to 24 mA to be driven into a load resistance of up to 1 k $\Omega$ with an AV<sub>DD1</sub> supply of greater than 24 V + headroom. It is important to ensure that the peak current does not cause the inductor to saturate, especially at the maximum ambient temperature. If the inductor enters saturation mode, it results in a decrease in efficiency. Larger size inductors translate to lower core losses. The slew rate control feature of the AD5758 can be used to limit peak currents during slewing. Program an appropriate current limit (via the DCDC\_CONFIG2 register) to shut off the internal switch if the inductor current reaches that limit.

#### DC-to-DC Converter Input and Output Capacitor Selection

The output capacitor,  $C_{DCDC}$ , affects the ripple voltage of the dcto-dc converter and limits the maximum slew rate at which the output current can rise. The ripple voltage is directly related to the output capacitance. The  $C_{DCDC}$  capacitor recommended by Analog Devices (see Table 10), combined with the recommended 47 µH inductor, results in a 500 kHz ripple with amplitude less than 50 mV and guarantees stability and operation with HART capability across all operating modes.

For high voltage capacitors, the size of the capacitor is often an indication of the charge storage ability. It is important to characterize the dc bias voltage vs. capacitance curve for this capacitor. Any capacitance values specified are with reference to a dc bias corresponding to the maximum  $V_{DPC+}$  voltage in the application. As well as the voltage rating, the temperature range of the capacitor must also be considered for a given application.

These considerations are key in selection of the components described in Table 10.

The input capacitor,  $C_{IN}$ , provides much of the dynamic current required for the dc-to-dc converter, and a low effective series resistance (ESR) component is recommended. For the AD5758, a low ESR tantalum or ceramic capacitor of 4.7  $\mu$ F (1206 size) in parallel with a 0.1  $\mu$ F (0402 size) capacitor is recommended. Ceramic capacitors must be chosen carefully because they can exhibit a large sensitivity to dc bias voltages and temperature. X5R or X7R dielectrics are preferred because these capacitors remain stable over wider operating voltage and temperature ranges. Care must be taken if selecting a tantalum capacitor to ensure a low ESR value.

#### CLKOUT

The AD5758 can provide a CLKOUT signal to the system for synchronization purposes. This signal is programmable to eight frequency options between 416 kHz and 588 kHz, with the default option being 500 kHz—the same switching frequency of the dc-to-dc converter. This feature is configured in the GP\_CONFIG1 register and is disabled by default

#### **INTERDIE 3-WIRE INTERFACE**

A 3-wire interface is used to communicate between the two die in the AD5758. The 3-wire interface master is located on the main die, and the 3-wire interface slave is on the dc-to-dc die. The three interface signals are data, DCLK (running at MCLK/8), and interrupt.

The main purpose of the 3-wire interface is to read from or write to the DCDC\_CONFIG1 and DCDC\_CONFIG2 registers. Addressing these registers via the SPI interface initiates an internal 3-wire interface transfer from the main die to the dc-todc die. The 3-wire interface master on the main die initiates writes and reads to the registers on the dc-to-dc die using DCLK as the serial clock. The slave uses an interrupt signal to the dc-to-dc die to indicate that a read of the dc-to-dc die internal status register is required.

For every 3-wire interface write, an automatic read and compare process can be enabled (default case) to ensure that the contents of the copy of the DCDC\_CONFIGx registers on the main die match the contents of the registers on the dc-to-dc die. This comparison is performed to ensure the integrity of the digital circuitry on the dc-to-dc die. With this feature enabled, a 3-wire interface transfer takes approximately 300 µs. When disabled, this transfer time reduces to 30 µs.

The BUSY\_3WI flag in the DCDC\_CONFIG2 register is asserted during the 3-wire interface transaction. The BUSY\_3WI flag is also set when the user updates the DAC range (via the DAC\_ CONFIG register, Bits[4:0]) due to the internal calibration memory refresh caused by this action, which requires a 3-wire interface transfer between the two die. A write to either of the DCDC\_ CONFIGx registers must not be initiated while BUSY\_3WI is asserted. If a write occurs while BUSY\_3WI is asserted, the new write is delayed until the current 3-wire interface (3WI) transfer completes.

#### **3-Wire Interface Diagnostics**

Any faults on the dc-to-dc die triggers an interrupt to the main die. An automatic status read of the dc-to-dc die is performed. After the read transaction, the main die retains a copy of the dc-to-dc die status bits (FAULT\_PROT\_SW\_ERR, DCDC\_P\_SC\_ERR, and DCDC\_P\_PWR\_ERR). These values are available in the ANALOG\_DIAG\_RESULTS register and via the OR'd analog diagnostic results bits in the status register. These bits also trigger the FAULT pin.

In response to the interrupt request, the main die (master) performs a 3-wire interface read operation to read the status of the dc-to-dc die. The interrupt is only asserted again by a subsequent dc-to-dc die fault flag, upon which the 3-wire interface initiates another status read transaction. If an interrupt signal is detected six times in a row, the interrupt detection mechanism is disabled until a 3-wire interface write transaction completes. This disabling prevents the 3-wire interface from being blocked because of the constant dc-to-dc die status read when the interrupt is toggling. The INTR\_SAT\_3WI flag in the DCDC\_CONFIG2 register indicates when this event occurs, and a write to either DCDC\_CONFIGx register resets this bit to 0.

During a 3-wire read or write operation, the address and data bits in the transaction produce parity bits. These parity bits are checked on the receive side and, if they do not match on both die, the ERR\_ 3WI bit in the DIGITAL\_DIAG\_RESULTS register is set. If the read and compare process is enabled and a parity error occurs, the 3WI\_RC\_ERR bit in the DIGITAL\_DIAG\_RESULTS register is also set.

#### **VOLTAGE OUTPUT**

#### Voltage Output Amplifier and V<sub>SENSE</sub> Functionality

The voltage output amplifier is capable of generating both unipolar and bipolar output voltages, and is also capable of driving a load of 1 k $\Omega$  in parallel with 2  $\mu$ F (with an external compensation capacitor) to AGND. Figure 78 shows the voltage output driving a load, R<sub>LOAD</sub>, on top of a common-mode voltage (V<sub>CM</sub>) of ±10 V. An integrated 2 M $\Omega$  resistor ensures that the amplifier loop is kept closed, thus preventing potential large destructive voltages on VI<sub>OUT</sub> due to the broken amplifier loop in applications where a cable may become disconnected from +V<sub>SENSE</sub>. If remote sensing of the load is not required, connect +V<sub>SENSE</sub> directly to VI<sub>OUT</sub> and connect –V<sub>SENSE</sub> directly to AGND.





#### Driving Large Capacitive Loads

The voltage output amplifier is capable of driving capacitive loads of up to 2  $\mu$ F with the addition of a 220 pF nonpolarized compensation capacitor. This capacitor, while allowing the AD5758 to drive higher capacitive loads and reduce overshoot, increases the settling time of the device and, therefore, affects the bandwidth of the system. Without the compensation capacitor, capacitive loads of up to 10 nF can be driven.

#### Voltage Output Short-Circuit Protection

Under normal operation, the voltage output sinks/sources up to 12 mA and maintains specified operation. The short-circuit current is typically 16 mA. If a short circuit is detected, the FAULT pin goes low and the VOUT\_SC\_ERR bit in the ANALOG\_DIAG\_RESULTS register is set.

#### FAULT PROTECTION SWITCHES

The AD5758 incorporates fault protection switches on the VI<sub>OUT</sub>, +V<sub>SENSE</sub>, and -V<sub>SENSE</sub> pins. The main function of the fault protection switch is to protect the internal circuitry associated with the output pin from overvoltages and fault conditions that can occur in harsh industrial environments. The switch performs this protection this by continuously monitoring the output pin for voltages outside of the V<sub>DPC+</sub> and AV<sub>SS</sub> rails. If a voltage outside of these limits is detected, the fault protection switches go high impedance and stay high impedance until the fault is removed.

Only the VI<sub>OUT</sub> fault protection switch is user-programmable. This switch can be opened or closed via the FAULT\_PROT\_ SW\_EN bit in the DCDC\_CONFIG1 register. The associated error flag (FAULT\_PROT\_SW\_ERR) is located in the ANALOG\_ DIAG\_RESULTS register. This diagnostic bit flags an error irrespective of whether the VI<sub>OUT</sub> fault protection switch is open or closed at the time of the error voltage.

#### CURRENT OUTPUT External Current Setting Resistor

As shown in Figure 74,  $R_{SET}$  is an internal sense resistor that forms part of the voltage to current conversion circuitry. The stability of the output current value over temperature is dependent on the stability of the value of  $R_{SET}$ . As a method of improving the stability of the output current over temperature, an external, 13.7 k $\Omega$ , low drift resistor can be connected between the  $R_A$  and  $R_B$  pins of the AD5758, to be used instead of the internal resistor.

Table 1 shows the performance specifications of the AD5758 with both the internal  $R_{SET}$  resistor and an external, 13.7 k $\Omega$   $R_{SET}$  resistor. The external  $R_{SET}$  resistor specification assumes an ideal resistor. The actual performance depends on the absolute value and temperature coefficient of the resistor used. Therefore, the resistor specifications directly affect the gain error of the output and the TUE.

To arrive at the absolute worst case overall TUE of the output with a particular external  $R_{SET}$  resistor, add the percentage absolute error of the  $R_{SET}$  resistor directly to the TUE of the AD5758 with the external  $R_{SET}$  resistor, shown in Table 1
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(expressed in % FSR). The temperature coefficient must also be considered, as well as the specifications of the external reference, if this is the option being used in the system.

The magnitude of the error derived from directly summing the absolute error and TC error of both the external R<sub>SET</sub> resistor and the external reference with the TUE specification of the AD5758 is unlikely to occur because the TC values of the individual components are not likely to exhibit the same drift polarity, and, therefore, an element of cancelation occurs. For this reason, add the TC values in a root of squares fashion. A further improvement can be gained by performing a two point calibration at zero scale and full scale, thus reducing the absolute errors of the voltage reference and the R<sub>SET</sub> resistor.

#### **Current Output Open-Circuit Detection**

When in current output mode, if the headroom available falls below the compliance range due to an open-loop circuit or an insufficient power supply voltage, the IOUT\_OC\_ERR flag in the ANALOG\_DIAG\_RESULTS register is asserted, and the FAULT pin goes low.

# INTERNAL CURRENT OUTPUT MONITOR

For unipolar current output ranges (0 mA to 24 mA, 0 mA to 20 mA, and 4 mA to 20 mA), an internal current monitor can be configured to monitor the output current (see Figure 79). This feature is disabled by default and can be enabled via the INT\_I\_MONITOR\_EN bit in the GP\_CONFIG2 register.

When enabled, this feature mirrors the programmed output current and scales it down by a factor of 128. The output current is then passed through a 10.67 k $\Omega$  sense resistor, such that the voltage developed across it can be digitized by the internal ADC. Therefore, 0 mA to 24 mA is represented by 0 V to 2 V.

The ADC result can be converted to a voltage by

$$Voltage = \frac{ADC \ Value}{2^{12}} \times 2.5$$

The output current can then be calculated as

$$Current = \frac{Voltage}{10,670} \times 128$$



Figure 79. Internal Current Output Monitor

### HART CONNECTIVITY

The AD5758 has a  $C_{HART}$  pin, onto which a HART signal can be coupled. The HART signal appears on the current output if the HART\_EN bit in the GP\_CONFIG1 register is enabled and the VI<sub>OUT</sub> output is also enabled.

Figure 80 shows the recommended circuit for attenuating and coupling the HART signal into the AD5758. To achieve 1 mA p-p at the VI<sub>OUT</sub> pin, a signal of approximately 125 mV p-p is required at the C<sub>HART</sub> pin. The HART signal appearing at the VI<sub>OUT</sub> pin is inverted relative to the signal input at the C<sub>HART</sub> pin.



Figure 80. Coupling the HART Signal

As well as their use in attenuating the incoming HART modem signal, a minimum capacitance of the combination of C1 and C2 is required to ensure that the bandwidth presented to the modem output signal passes the 1.2 kHz and 2.2 kHz frequencies. Assuming a HART signal of 500 mV p-p, the recommended values are C1 = 47 nF and C2 = 150 nF. Digitally controlling the slew rate of the output is necessary to meet the analog rate of change requirements for HART.

If the HART feature is not required, disable the HART\_EN bit and leave the  $C_{HART}$  pin open circuit. However, if it is required to slow the DAC output signal with a capacitor, the HART\_EN bit must be enabled and the required  $C_{SLEW}$  capacitor connected to the  $C_{HART}$  pin.

### **DIGITAL SLEW RATE CONTROL**

The slew rate control feature of the AD5758 allows the user to control the rate at which the output value changes. This feature is available in both current and voltage mode. With the slew rate control feature disabled, the output value changes at a rate limited by the output drive circuitry and the attached load. To reduce the slew rate, enable the slew rate control feature. With this feature enabled, the output steps digitally from one value to the next at a rate defined by two parameters accessible via the DAC\_CONFIG register. The parameters are SR\_CLOCK and SR\_STEP. SR\_CLOCK defines the rate at which the digital slew is updated. For example, if the selected update rate is 8 kHz, the output updates every 125  $\mu$ s. In conjunction with SR\_CLOCK, SR\_STEP defines by how much the output value changes at each update. Together, both parameters define the rate of change of the output value.

The following equation describes the slew rate as a function of the step size, the update clock frequency, and the LSB size:

Slew Time = <u>
Step Size × Update Clock Frequency</u> × LSB Size

where:

Slew Time is expressed in seconds.

*Output Change* is expressed in amps for current output mode or volts for voltage output mode.

When the slew rate control feature is enabled, all output changes occur at the programmed slew rate. For example, if the WDT times out and an automatic clear occurs, the output slews to the clear value at the programmed slew rate (setting the CLEAR\_NOW\_ EN bit in the GP\_CONFIG1 register overrides this default behavior to cause the output to update to the clear code immediately, rather than at the programmed slew rate).

The update clock frequency for any given value is the same for all output ranges. The step size, however, varies across output ranges for a given value of step size because the LSB size is different for each output range.

# **DEVICE UNDER TEST (DUT) ADDRESS PINS**

The DUT address pins (AD0 and AD1) are used in conjunction with the DUT address bits within the SPI frame (see Table 12) to determine which AD5758 device is being addressed by the system controller. With the two address pins, up to four devices can be independently addressed on one board.

# SPI Interface and Diagnostics

The AD5758 is controlled over a 4-wire serial interface with an 8-bit cyclic redundancy check (CRC-8) enabled by default. The input shift register is 32 bits wide, and data is loaded into the device MSB first under the control of a serial clock input, SCLK. Data is clocked in on the falling edge of SCLK. If CRC is disabled, the serial interface is reduced to 24 bits; a 32-bit frame is still accepted but the last 8 bits are ignored.

| Table 12. Writing to a Register (CRC enabled) |  |
|---|--|
| MCR   |  |

| MSB      |             |                  |          | LSB     |
|----------|-------------|------------------|----------|---------|
| D31      | [D30:D29]   | [D28:D24]        | [D23:D8] | [D7:D0] |
| Slip bit | DUT address | Register address | Data     | CRC     |

As shown in Table 12, every SPI frame contains two DUT address bits. These bits must match the hardware DUT address pins (AD0 and AD1) for a particular device to accept the SPI frame on the bus.

# SPI Cyclic Redundancy Check

To verify that data has been received correctly in noisy environments, the AD5758 offers the option of CRC based on a CRC-8. The device controlling the AD5758 generates an 8-bit frame check sequence using the following polynomial:

$$C(x) = x^8 + x^2 + x^1 + 1$$

This sequence is added to the end of the data-word, and 32 bits are sent to the AD5758 before taking  $\overline{\text{SYNC}}$  high.

If the SPI\_CRC\_EN bit is set high (default state), the user must supply a frame of exactly 32 bits wide that contains the 24 data bits and 8-bit CRC. If the CRC check is valid, the data is written to the selected register. If the CRC check fails, the data is ignored, the FAULT pin goes low and the FAULT pin status bit and the digital diagnostic status bit (DIG DIAG STATUS) in the status register are asserted. A subsequent readback of the DIGITAL DIAG RESULTS register reveals that the SPI\_CRC\_ERR bit is also set. This register is a per bit, write to clear register (see the Sticky Diagnostic Results Bits section); therefore, the SPI\_CRC\_ERR bit can be cleared by writing a 1 to Bit D0 of the DIGITAL\_DIAG\_ RESULTS register. Doing so clears the SPI\_CRC\_ERROR bit and causes the FAULT pin to return high (assuming that there are no other active faults). When configuring the FAULT\_PIN CONFIG register, the user can decide whether the SPI CRC error affects the FAULT pin. See the FAULT Pin Configuration Register section for further details. The SPI CRC feature can be used for both the transmission and receipt of data packets.



# SPI Interface Slip Bit

A further enhancement to the robustness of the interface is the addition of the slip bit. The MSB of the SPI frame must equal the inverse of the MSB – 1 for the frame to be considered valid. If an incorrect slip bit is detected, the data is ignored and the SLIPBIT\_ERROR bit in the DIGITAL\_DIAG\_RESULTS register is asserted.

### SPI Interface SCLK Count Feature

An SCLK count feature is also built into the SPI diagnostics, meaning that only SPI frames with exactly 32 SCLK falling edges (32 or 24 if SPI CRC is disabled) are accepted by the interface as a valid write. SPI frames of lengths other than these values are ignored and the SCLK\_COUNT\_ERR flag asserts in the DIGITAL\_DIAG\_RESULTS register.

#### **Readback Modes**

The AD5758 offers four readback modes, as follows:

- Two stage readback mode
- Autostatus readback mode
- Shared SYNC autostatus readback mode
- Echo mode

The two stage readback consists of a write to a dedicated register, TWO\_STAGE\_READBACK\_SELECT, to select the register location to be read back. This write is followed by a no operation (NOP) command, during which the contents of the selected register are available on SDO.

# Table 13. SDO Contents for Read Operation **MSB**

| MSD       |                  |                  | 230      |         |
|-----------|------------------|------------------|----------|---------|
| [D31:D30] | D29              | [D28:24]         | [D23:D8] | [D7:D0] |
| 0b10      | FAULT pin status | Register address | Data     | CRC     |

ICR

Bits[D31:D30] = 0b10 are used for synchronization purposes during readback.

If autostatus readback mode is selected, the contents of the status register are available on the SDO line during every SPI transaction. This feature allows the user to continuously monitor the status register and act quickly in the case of a fault. The AD5758 powers up with this feature disabled. When this feature is enabled, the normal two stage readback feature is not available. Only the status register is available on SDO. To read back any other register, disable the automatic readback feature first before following the two stage readback sequence. The automatic status register is readback can be reenabled after the register is read back.

The shared  $\overline{\text{SYNC}}$  autostatus readback is a special version of the autostatus readback mode used to avoid SDO bus contention when multiple devices are sharing the same  $\overline{\text{SYNC}}$  line.

Echo mode behaves similarly to autostatus readback mode, except that every second readback consists of an echo of the previous command written to the AD5758 (see Figure 82). See the Reading from Registers section for further details on the readback modes.



Figure 82. SDO Contents, Echo Mode

# WATCHDOG TIMER (WDT)

The WDT feature is useful to ensure that communication is not lost between the system controller and the AD5758 and that the SPI datapath lines function as expected.

When enabled, the WDT alerts the system if the AD5758 has not received a specific SPI frame in the user-programmable timeout period. When the specific SPI frame is received, the watchdog resets the timer controlling the timeout alert. The SPI frame used to reset the WDT is configurable as one of the two following choices:

- A specific key code write to the key register (default).
- A valid SPI write to any register.

On a watchdog timeout event, a dedicated WDT\_STATUS bit in the status register, as well as a WDT\_ERR bit in the DIGITAL\_ DIAG\_RESULTS register, alerts the user that the WDT timed out. Note that, after a WDT timeout occurs, all writes to the DAC\_INPUT register, as well as the hardware or software LDAC events, are ignored until the active WDT fault flag within the DIGITAL\_DIAG\_RESULTS register clears.

After this flag clears, the WDT can be restarted by performing a subsequent WDT reset command.

On power-up, the WDT is disabled by default. The default timeout setting is 1 sec. The default method to reset the WDT is to write one specific key and, on timeout, the default action is to set the relevant flag bits and the  $\overline{FAULT}$  pin. See Table 40 for the specific register bit details to support the configurability of the WDT operation.

# USER DIGITAL OFFSET AND GAIN CONTROL

The AD5758 has a USER\_GAIN register and a USER\_OFFSET register that allow trimming of the gain and offset errors from the entire signal chain. The 16-bit USER\_GAIN register allows the user to adjust the gain of the DAC channel in steps of 1 LSB. The USER\_GAIN register coding is straight binary, as shown in Table 14. The default code in the USER\_GAIN register is 0xFFFF, which results in no gain factor applied to the programmed output. In theory, the gain can be tuned across the full range of the output. In practice, the maximum recommended gain trim is approximately 50% of the programmed range to maintain accuracy.

Table 14. Gain Register Adjustment

| D15 | D14 to D1 | D0         |  |
|-----|-----------|------------|--|
| 1   | 1         | 1          |  |
| 1   | 1         | 0          |  |
|     |           |            |  |
| 0   | 0         | 1          |  |
| 0   | 0         | 0          |  |
|     | 1         | 1 1<br>1 1 |  |

The 16-bit USER\_OFFSET register allows the user to adjust the offset of the DAC channel by -32,768 LSBs to +32,768 LSBs in steps of 1 LSB. The USER\_OFFSET register coding is straight binary, as shown in Table 15. The default code in the USER\_OFFSET register is 0x8000, which results in zero offset programmed to the output.

#### Table 15. Offset Register Adjustment

| Gain Adjustment         | D15 | D13 to D2 | D0 |
|-------------------------|-----|-----------|----|
| +32,768 LSBs            | 1   | 1         | 1  |
| +32,767 LSBs            | 1   | 1         | 0  |
|                         |     |           |    |
| No Adjustment (Default) | 1   | 0         | 0  |
|                         |     |           |    |
| -32,767 LSBs            | 0   | 0         | 1  |
| -32,768 LSBs            | 0   | 0         | 0  |

The value (in decimal) that is written to the internal DAC register can be calculated by

DAC \_Code = 
$$D \times \frac{(M+1)}{2^{16}} + C - 2^{15}$$
 (1)

where:

*D* is the code loaded to the DAC\_INPUT register.

*M* is the code in the USER\_GAIN register (default code =  $2^{16} - 1$ ). *C* is the code in the USER\_OFFSET register (default code =  $2^{15}$ ).

Data from the DAC\_INPUT register is processed by a digital multiplier and adder, controlled by the contents of the user gain and USER\_OFFSET registers, respectively. The calibrated DAC data is then loaded to the DAC, dependent on the state of the LDAC pin.

Each time data is written to the USER\_GAIN or USER\_ OFFSET register, the DAC output is not automatically updated. Instead, the next write to the DAC\_INPUT register uses these user gain and user offset values to perform a new calibration and automatically updates the channel. The read only DAC\_ OUTPUT register represents the value currently available at the DAC output, except in the case of user gain and user offset calibration. In this case, the DAC\_OUTPUT register represents the DAC data input by the user, on which the calibration is performed and not the result of the calibration.

Both the USER\_GAIN register and the USER\_OFFSET register have 16 bits of resolution. The correct method to calibrate the gain and offset is to first calibrate the gain and then calibrate the offset.

# DAC OUTPUT UPDATE AND DATA INTEGRITY DIAGNOSTICS

Figure 83 shows a simplified version of the DAC input loading circuitry. If used, the USER\_GAIN and USER\_OFFSET registers must be updated before writing to the DAC\_INPUT register.



Figure 83. Simplified Serial Interface of Input Loading Circuitry

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The DAC\_OUTPUT register (and ultimately the DAC output) updates in any of the following cases:

- If a write is performed to the DAC\_INPUT register with the hardware LDAC pin tied low, the DAC\_OUTPUT register is updated on the rising edge of SYNC and is subject to the timing specifications in Table 2.
- If the hardware LDAC pin is high and a write to the DAC\_INPUT register occurs, the DAC\_OUTPUT register does not update until a software LDAC instruction is issued or the hardware LDAC pin is pulsed low.
- If a WDT timeout occurs with the CLEAR\_ON\_WDT\_ FAIL bit set, the CLEAR\_CODE register contents are loaded into the DAC\_OUTPUT register.
- If the slew rate control feature is enabled, the DAC\_ OUTPUT register contains the dynamic value of the DAC as it slews between values.

Note that, while a WDT fault is active, all writes to the DAC\_ INPUT register, as well as hardware or software LDAC events, are ignored. If the CLEAR\_ON\_WDT\_FAIL bit is set such that the output is set to the clear code, when the WDT fault flag clears, the DAC\_INPUT register must be written to before an update to the DAC\_OUTPUT register occurs; that is, performing a software or hardware LDAC only reloads the DAC with the clear code. As described in the section, after configuring the DAC range via the DAC\_CONFIG register, a write to the DAC\_ INPUT register must occur, even if the contents of the DAC\_ INPUT register are not changing from their current value.

The GP\_CONFIG2 register contains a bit to enable a global software LDAC mode, whereby the DUT address bits of the SW\_LDAC command are ignored, thus enabling multiple AD5758 devices to be simultaneously updated using a single <u>SW\_LDAC</u> command. This feature is useful if the hardware <u>LDAC</u> pin is not being used in a system containing multiple AD5758 devices.

#### DAC Data Integrity Diagnostics

To protect against transient changes to the internal digital circuitry, the digital block stores both the digital DAC value and an inverted copy of the digital DAC value. A check is completed to ensure that the two values correspond to each other before the DAC is strobed to update to the DAC code. This feature is enabled by default via the INVERSE\_DAC\_CHECK\_EN bit in the DIGITAL\_DIAG\_CONFIG register.

Outside of the digital block, the DAC code is stored in latches, as shown in Figure 84. These latches are potentially vulnerable to the same transient events as those protected against within the digital block. To protect the DAC latches against such transients, the DAC latch monitor feature can be enabled via the DAC\_LATCH\_MON\_EN bit within the DIGITAL\_DIAG\_CONFIG register. This feature monitors the actual digital code driving the DAC and compares it with the digital code generated within the digital block. Any difference between the two codes

causes the DAC\_LATCH\_MON\_ERR flag to be set in the DIGITAL\_DIAG\_RESULTS register.



# **USE OF KEY CODES**

Key codes (via the key register) are used for the following functions (see the Key Register section for full details):

- Initiate calibration memory refresh.
- Initiate a software reset.
- Initiate a single ADC conversion.
- WDT reset key.

Using specific keys for initiating such actions as a calibration memory refresh or a device reset provides extra system robustness because it reduces the probability of either of these tasks being initiated in error.

### SOFTWARE RESET

A software reset requires two consecutive writes to the key register, 0x15FA and 0xAF51, respectively. A reset of the device can be initiated via the hardware RESET pin, the software reset keys, or automatically after a WDT timeout (if configured to do so). The RESET\_OCCURRED bit in the DIGITAL\_DIAG\_RESULTS register flags when the device is reset. This bit defaults to 1 on power-up. Both of the diagnostic results registers implement a write 1 to clear feature; that is, a 1 must be written to this bit to clear it (see the Sticky Diagnostic Results Bits section).

# **CALIBRATION MEMORY CRC**

For every calibration memory refresh cycle (which is initiated via a key code write to the key register or automatically initiated when the range bits, Bits[3:0] of the DAC\_CONFIG register, are changed), an automatic CRC is calculated on the contents of the calibration memory shadow registers. The result of this CRC is compared with the factory stored reference CRC value. If the CRC values match, the read of the entire calibration memory is considered valid. If they do not match, the CAL\_MEM\_CRC\_ERR bit in the DIGITAL\_DIAG\_RESULTS register is set to 1. This feature is enabled by default and can be disabled via the CAL\_MEM\_CRC\_EN bit in the DIGITAL\_DIAG\_CONFIG register.

While this calibration memory refresh cycle is active, two stage readback commands are permitted, but a write to any register (other than the TWO\_STAGE\_READBACK\_SELECT register or the NOP register) causes the INVALID\_SPI\_ACCESS\_ERR bit in the DIGITAL\_DIAG\_RESULTS register to set. As described in the section, a wait period of 500 µs is recommended after a calibration memory refresh cycle is initiated.

# INTERNAL OSCILLATOR DIAGNOSTICS

An internal frequency monitor uses the internal oscillator (MCLK) to increment a 16-bit counter at a rate of 1 kHz (MCLK/10,000). The value of the counter is available to be read in the FREQ\_MONITOR register. The user can poll this register periodically and use it both as a diagnostic tool for the internal oscillator (to monitor that the oscillator is running), and to measure the frequency. This feature is enabled by default via the FREQ\_MON\_EN bit in the DIGITAL\_DIAG\_CONFIG register.

In the event that the internal MCLK oscillator stops, the AD5758 sends a specific code of 0x07DEAD to the SDO line for every SPI frame. This feature is enabled by default and can be disabled by clearing the OSC\_STOP\_DETECT\_EN bit in the GP\_CONFIG1 register. Note that this feature is limited to the maximum readback timing specifications as outlined in Table 3.

# STICKY DIAGNOSTIC RESULTS BITS

The AD5758 contains two diagnostic results registers: digital and analog (see Table 45 and Table 46, respectively). The diagnostic result bits contained within these registers are sticky (R/W-1-C), that is, each bit needs a 1 to be written to it to clear it. A more appropriate word here is update rather than clear because if the fault is still present, even after writing a 1 to the bit in question, it does not clear to 0. Upon writing Logic 1 to the bit, it updates to its latest value, which is Logic 1 if the fault is still present and Logic 0 if the fault is no longer present.

There are two exceptions to this R/W-1-C access within the DIGITAL\_DIAG\_RESULTS register: CAL\_MEMORY\_UNREFRESHED and SLEW\_BUSY. These flags automatically clear when the calibration memory refresh or output slew, respectively, is complete.

The status register contains a DIG\_DIAG\_STATUS and ANA\_DIAG\_STATUS bit, which is the result of a logical OR of the diagnostic results bits contained in each of the diagnostic results registers. All analog diagnostic flag bits are included in the logical OR of the ANA\_DIAG\_STATUS bit and all digital diagnostic flag bits, with the exception of the SLEW\_BUSY bit, are included in the logical OR of the DIG\_DIAG\_STATUS bit. The OR'd bits within the status register are read only and not sticky (R/W-1-C).

# BACKGROUND SUPPLY AND TEMPERATURE MONITORING

Excessive die temperature and overvoltage are known to be related to common cause failures. These conditions can be monitored in a continuous fashion using comparators, eliminating the requirement to poll the ADC.

Both die have a built-in temperature sensor with an accuracy of typically ±5°C. The main die temperature is monitored by a comparator. The background temperature comparator is permanently enabled. Programmable trip points corresponding to 142°C, 127°C, 112°C, and 97°C can be configured in the GP\_CONFIG1 register. If the temperature of the main die exceeds

the programmed limit, the relevant status bit in the ANALOG\_ DIAG\_RESULTS register is set and the FAULT pin is asserted low.

The low voltage supplies on the AD5758 are monitored via low power static comparators. This function is disabled by default and can be enabled via the COMPARATOR\_CONFIG bits in the GP CONFIG2 register. Note that the INT EN bit in the DAC\_CONFIG register must be set for the REFIN buffer to be powered up and for this node to be available to the REFIN comparator. The monitored nodes are REFIN, REFOUT, VLDO, and an internal  $AV_{CC}$  voltage node (INT\_AVCC). There is a status bit in the ANALOG DIAG RESULTS register corresponding to each monitored node. If any of the supplies exceed the upper or lower threshold values (see Table 16), the corresponding status bit is set. Note that, in the case of a REFOUT fault, the REFOUT\_ERR status bit is set. In this case, the INT\_AVCC, V<sub>LDO</sub>, and temperature comparator status bits may also become set because REFOUT is used as the comparison voltage for these nodes. Like all the other status bits in the ANALOG DIAG\_RESULTS register, these bits are sticky and need a 1 to be written to them to clear them, assuming that the error condition subsided. If the error condition is still present, the flag remains high, even after a 1 is written to clear it.

| Table 16. Comparator Sup | ply Activation Thresholds |
|--------------------------|---------------------------|
|--------------------------|---------------------------|

| Supply           | Lower<br>Threshold (V) | Nominal<br>Value/Range (V) | Upper<br>Threshold (V) |
|------------------|------------------------|----------------------------|------------------------|
| INT_AVCC         | 3.8                    | 4 to 5                     | 5.2                    |
| V <sub>LDO</sub> | 2.8                    | 3 to 3.6                   | 3.8                    |
| REFIN            | 2.24                   | 2.5                        | 2.83                   |
| REFOUT           | 2.24                   | 2.5                        | 2.83                   |

# **OUTPUT FAULT**

The AD5758 is equipped with a FAULT pin. This pin is an active low, open-drain output allowing several AD5758 devices to be connected together to one pull-up resistor for global fault detection. This pin is high impedance when no faults are detected and is asserted low when certain faults are detected, for example, an open circuit in current mode, a short circuit in voltage mode, a CRC error, or an overtemperature error. Table 17 shows the fault conditions that automatically force the FAULT pin active and highlights the user maskable fault bits available via the FAULT\_ PIN\_CONFIG register (see Table 43). Note that all registers contain a corresponding FAULT pin status bit, FAULT\_PIN\_ STATUS, that mirrors the inverted current state of the FAULT pin. For example, if the FAULT pin is active, the FAULT\_ PIN\_STATUS bit is 1.

### Table 17. FAULT Pin Trigger Sources<sup>1</sup>

| Table 17. FAULT PIII Trigger Sources |                                |                 |
|--------------------------------------|--------------------------------|-----------------|
| Fault Type                           | <u>Mapp</u> ed to<br>FAULT Pin | Mask<br>Ability |
| Digital Diagnostic Faults            |                                |                 |
| Oscillator Stop Detect               | Yes                            | Yes             |
| Calibration Memory Not Refreshed     | No                             | N/A             |
| Reset Detected                       | No                             | N/A             |
| 3-Wire Interface Error               | Yes                            | No              |
| WDT Error                            | Yes                            | Yes             |
| 3-Wire Read and Compare Parity Error | Yes                            | No              |
| DAC Latch Monitor Error              | Yes                            | Yes             |
| Inverse DAC Check Error              | Yes                            | Yes             |
| Calibration Memory CRC Error         | Yes                            | No              |
| Invalid SPI Access                   | Yes                            | Yes             |
| SCLK Count Error                     | Yes                            | No <sup>2</sup> |
| Slip Bit Error                       | Yes                            | Yes             |
| SPI CRC Error                        | Yes                            | Yes             |
| Analog Diagnostic Faults             |                                |                 |
| Vlout Fault Protection Switch Error  | Yes                            | Yes             |
| DC-to-DC Short Circuit Error         | Yes                            | Yes             |
| DC-to-DC Power Error                 | Yes                            | No              |
| Current Output Open Circuit Error    | Yes                            | Yes             |
| Voltage Output Short-Circuit Error   | Yes                            | Yes             |
| Main Die Temperature Error           | Yes                            | Yes             |
| <b>REFFOUT</b> Comparator Error      | Yes                            | No              |
| <b>REFIN Comparator Error</b>        | Yes                            | No              |
| INT_AVCC Comparator Error            | Yes                            | No              |
| V <sub>LDO</sub> Comparator Error    | Yes                            | No              |

<sup>1</sup> N/A means not applicable.

<sup>2</sup> Although the SCLK count error cannot <u>be masked</u> in the FAULT\_PIN\_CONFIG register, it can be excluded from the FAULT pin by enabling the SPI\_DIAG\_ QUIET\_EN bit (Bit D3 in the GP\_CONFIG1 register).

The DIG\_DIAG\_STATUS, ANA\_DIAG\_STATUS, and WDT\_ STATUS bits of the status register are used in conjunction with the FAULT pin and the FAULT\_PIN\_STATUS bit to inform the user which one of the fault conditions caused the FAULT pin or the FAULT\_PIN\_STATUS bit to be activated.

# ADC MONITORING

The AD5758 incorporates a 12-bit ADC to provide diagnostic information on user-selectable inputs, such as supplies, grounds, internal die temperatures, references, and external signals. See Table 18 for a full list of the selectable inputs. The reference used for the ADC is derived from REFOUT, providing a means of independence from the DAC reference (REFIN), if necessary. The ADC\_CONFIG register configures the mode of operation of the ADC (user initiated individual conversions or sequence mode), as well as selection of the multiplexed ADC input channel via the ADC\_IP\_SELECT bits (see Table 42).

### ADC Transfer Function Equations

The ADC has an input range of 0 V to 2.5 V and can be used to digitize a variety of different nodes. The set of inputs to the ADC encompasses both unipolar and bipolar ranges, varying from high to low voltage values. Therefore, to be able to digitize them, the voltage ranges outside of the 0 V to 2.5 V ADC input range must be divided down. The ADC transfer function equation is dependent on the selected ADC input node (see Table 18 for a summary of all transfer function equations).

| ADC_IP_SELECT | V <sub>IN</sub> Node Description   | ADC Transfer Function  |
|---------------|--|--|
| 00000         | Main die temperature   | $T (^{\circ}C) = (-0.09369 \times D) + 307$                        |
| 00001         | DC-to-dc die temperature   | $T(^{\circ}C) = (-0.11944 \times D) + 436$                         |
| 00010         | Reserved   | Reserved   |
| 00011         | REFIN  | $V_{IN}(V) = (D/2^{12}) \times 2.5 \times 2 = (D/2^{12}) \times 5$ |
| 00100         | Internal 1.23 V reference voltage (REF2)   | $V_{IN}(V) = (D/2^{12}) \times 2.5$                                |
| 00101         | Reserved   | Reserved   |
| 00110         | Reserved   | Reserved   |
| 01100         | Reserved   | Reserved   |
| 01101         | Voltage on the +V <sub>SENSE</sub> buffer output <sup>1</sup>                        | $V_{IN}(V) = (50 \times D)/2^{12} - 25$                            |
| 01110         | Voltage on the –V <sub>SENSE</sub> buffer output <sup>1</sup>                        | $V_{IN}(V) = (50 \times D)/2^{12} - 25$                            |
| 10000         | Reserved   | Reserved   |
| 10001         | Reserved   | Reserved   |
| 10010         | Reserved   | Reserved   |
| 10011         | Reserved   | Reserved   |
| 10100         | INT_AVCC   | $V_{IN}(V) = D/2^{12} \times 2.5 \times 4 = D/2^{12} \times 10$    |
| 10101         | VLDO   | $V_{IN}(V) = D/2^{12} \times 2.5 \times 4 = D/2^{12} \times 10$    |
| 10110         | VLOGIC   | $V_{IN}(V) = D/2^{12} \times 2.5 \times 4 = D/2^{12} \times 10$    |
| 10111         | Internal current monitor output voltage; the output range of this node is 0 V to 2 V | $V_{IN}(V) = D/2^{12} \times 2.5$                                  |
| 11000         | REFGND   | $V_{IN}(V) = D/2^{12} \times 2.5$                                  |

| ADC_IP_SELECT | V <sub>IN</sub> Node Description                           | ADC Transfer Function  |
|---------------|--|--|
| 11001         | AGND   | $V_{IN}(V) = D/2^{12} \times 2.5$                                  |
| 11010         | DGND   | $V_{IN}(V) = D/2^{12} \times 2.5$                                  |
| 11011         | V <sub>DPC+</sub>  | $V_{IN}(V) = D/2^{12} \times 2.5 \times 15 = D/2^{12} \times 37.5$ |
| 11100         | AV <sub>DD2</sub>  | $V_{IN}(V) = D/2^{12} \times 2.5 \times 15 = D/2^{12} \times 37.5$ |
| 11101         | AV <sub>ss</sub>   | $V_{IN}(V) = (15 \times D/2^{12} - 14) \times 2.5$                 |
| 11110         | DC-to-dc die node; configured in the DCDC_CONFIG2 register |  |
|               | 00: AGND on dc-to-dc die                                   | $V_{IN}(V) = (D/2^{12}) \times 2.5$                                |
|               | 01: internal 2.5 V supply on dc-to-dc die                  | $V_{IN}(V) = (D/2^{12}) \times 2.5 \times 2 = (D/2^{12}) \times 5$ |
|               | 10: AV <sub>DD1</sub>                                      | $V_{IN}(V) = D/2^{12} \times 2.5 \times 15 = D/2^{12} \times 37.5$ |
|               | 11: reserved   | Reserved   |
| 11111         | REFOUT   | $V_{IN}(V) = (D/2^{12}) \times 2.5$                                |

<sup>1</sup> Selecting any of the V<sub>SEMSE</sub> buffers as an input to the ADC reduces the step size in PPC current mode (see the PPC Current Mode section) to 0.667 V. This reduction, in turn, changes the current output PPC mode V<sub>DPC+</sub> voltage range to 5 V to 25.677 V.



Figure 85. Diagnostic ADC Input Nodes

### ADC Configuration

The ADC is configured using the ADC\_CONFIG register via SEQUENCE\_COMMAND (Bits[10:8]), SEQUENCE\_DATA (Bits[7:5]), and ADC\_IP\_SELECT (Bits[4:0]).

#### Table 19. ADC Configuration Register

| D10 to D8 | D7 to D5 | D4 to D0         |
|-----------|----------|------------------|
| Command   | Data     | ADC input select |

The ADC can be set up to monitor a single node of interest or configured to sequence through up to eight nodes of interest. The sequential conversions can be initiated automatically after every valid SPI frame is received by the device (automatic sequence mode), or in a more controlled manner via a specific key code written to the key register (key sequence mode). When a conversion is complete, the ADC result is available in the status register and, if in sequence mode, the sequencer address is advanced. If autostatus readback mode is used in conjunction with either sequence mode, the last completed ADC conversion data is available on SDO during every SPI frame written to the device.

The sequencer has a maximum channel depth of 8. Each of the channels in the sequencer must be configured with the select bits of the required ADC input for that sequencer channel, and the number of configured channels must equal the depth. If any active sequencer channel location is not configured correctly, it stores the previous value loaded to that channel, defaulting initially to the ADC input option of 0b00000 for all sequencer channels. If a node from the dc-to-dc die is required to be part of the ADC sequencer, perform this configuration using the DCDC\_ADC\_CONTROL\_DIAG bits in the DCDC\_CONFIG2 register before configuring the ADC sequencer, to avoid any 3-wire interface related delays between ADC conversions. If multiple nodes from the dc-to-dc die are required within the sequence, key sequencing mode must be used rather than automatic sequencing mode, because the DCDC\_ADC\_ CONTROL\_DIAG bits must be updated between ADC conversions to configure the next required dc-to-dc die node required by the sequence.

The four modes of operation are key sequencing, automatic sequencing, single immediate conversion, and single key conversion. The sequencing modes are mutually exclusive. If enabled, the key sequencing mode disables the automatic sequencing mode, and vice versa.

# Key Sequencing (Command 010)

Writing Command 010 enables key sequencing mode. Sequencing starts with a write to the key register with Key Code 0x1 ADC, starting on Channel 0 and continuing to Channel N – 1, where N is the depth, with every 0x1ADC command. This mode enables user control of the switching of channels during sequencing because the switch occurs only for every specific key code command, rather than for every valid SPI frame, as in the case of automatic sequencing mode. When the sequence is completed, it starts again with Channel 0 until disabled. Command 000 and Command 001 must be used to configure all the required channels before Command 0b010 is issued to enable key sequencing mode (see Figure 86). If the sequencing is disabled and later reenabled, the sequencer is reset to recommence converting on the first channel in the sequence.

### Automatic Sequencing (Command 011)

Sequencing starts on the next valid SPI frame, starting with Channel 0 and continuing to Channel N – 1, where N is the depth, on every valid SPI frame. When the sequence is complete, it starts again with Channel 0 until disabled. As with the key sequencing mode, Command 000 and Command 001 must be used to configure all the required channels before Command 011 is issued to enable automatic sequencing mode (see Figure 86). If the sequencing is disabled and later reenabled, the sequencer is reset to recommence converting on the first channel in the sequence. When reenabled, the channels do not need to be reconfigured unless the desired list of nodes changes. Use automatic sequencing in conjunction with the autostatus readback mode to ensure that the latest ADC result is available.

#### Single Immediate Conversion (Command 100)

This mode initiates a single conversion on the node currently selected in the ADC input select bits of the ADC\_CONFIG register. Selecting this command stops any active automatic sequence, meaning that it must be reenabled if required. The sequencer does not need to be reconfigured because the configuration of sequencer depth and channels is stored.

# Single Key Conversion (Command 101)

This mode is used to set up an individual ADC input node to be converted at some future time, initiated by writing the 0x1ADC key code to the key register.

#### Sequencing Mode Setup

A list of the relevant ADC sequencer commands are shown in Table 20 (these are available in the ADC\_CONFIG register; see Table 42). The default depth (000) is equivalent to one diagnostic channel up to a binary depth value of 111, which is equivalent to eight channels.

| Table 20. Con | nmand Bits |
|---------------|------------|
|---------------|------------|

| Value | Description   |
|-------|---|
| 000   | Set the sequencer depth (0 to 7)  |
| 001   | Load sequencer Channel N with the selected ADC input  |
| 010   | Enable/disable key sequencer  |
| 011   | Enable/disable automatic sequencer  |
| 100   | Perform a single conversion on the currently selected ADC input   |
| 101   | Set up single key conversion, that is, select the ADC mux<br>input to be used when triggered with a write to the key<br>register (this is outside of the key sequencing mode) |

Use the following procedure to set up the sequencer:

- 1. Select the depth.
- 2. Load the channels into the sequencer N times for N channels.
- 3. Enable the sequencer. The act of enabling the sequencer also starts the first conversion.

An example of configuring the sequencer to monitor three ADC nodes is shown in Figure 86.



Figure 86. Example Automatic Sequence Mode Setup for Three ADC Input Nodes

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### ADC Conversion Timing

Figure 87 shows an example where autostatus readback mode is enabled. The status register always contains the last completed ADC conversion result, together with the associated mux address, ADC\_IP\_SELECT.

This example is applicable irrespective of the ADC conversion mode in use (key sequencing, automatic sequencing, single immediate conversion, or single key conversion). During the first ADC conversion command shown, the contents of the status register are available on the SDO line. The ADC portion of this data contains the conversion result of the previously converted ADC node (ADC Conversion Result 0), as well as the associated channel address. Assuming another SPI frame is not received while the ADC is busy converting due to Command 1, the next data to appear on the SDO line contains the associated conversion result, ADC Conversion Result 1. However, if an SPI frame is received while the ADC is busy, the status register contents available on SDO still contain the previous conversion result and indicates that the ADC\_BUSY flag is high. Any new ADC conversion instructions received while the ADC\_BUSY bit is active are ignored. If using a sequencer mode, the sequencer address is updated after the conversion completes.



Figure 87. ADC Conversion Timing Example

# **REGISTER MAP**

The AD5758 is controlled and configured via 29 on-chip registers described in the Register Details section. The four possible access permissions are as follows:

- R/W: read/write •
- R: read only
- R/W-1-C: read/write 1 to clear •
- R0/W: read zero/write .

Reading from and writing to reserved registers is flagged as an invalid SPI access (see Table 45). When accessing registers with reserved bit fields, the default value of those bit fields must be written. These values are listed in the Reset column of Table 27 to Table 50.

# Table 21. Writing to a Register

| WRIT   | ING T | O R | EGIS | T | EF | RS |  |
|--------|-------|-----|------|---|----|----|--|
| T 4 71 | • . • |     |      |   |    | .1 |  |

When writing to any register, the format in Table 21 is used. By default, the SPI CRC is enabled and the input register is 32 bits wide, with the last eight bits corresponding to the CRC code. Only frames of exactly 32 bits wide are accepted as valid. If CRC is disabled, the input register is 24 bits wide;, and 32-bit frames are also accepted, with the final 8 bits ignored. Table 22 describes the function of Bit D23 to Bit D16. Bit D15 to Bit D0 depend on the register that is being addressed.

| MSB     |         |         |          |          |          |          |          |           |  |
|---------|---------|---------|----------|----------|----------|----------|----------|-----------|--|
| D23     | D22     | D21     | D20      | D19      | D18      | D17      | D16      | D15 to D0 |  |
| DUT_AD1 | DUT_AD1 | DUT_AD0 | REG_ADR4 | REG_ADR3 | REG_ADR2 | REG_ADR1 | REG_ADR0 | Data      |  |

#### Table 22. Input Register Decode

| Bit   | Description  |
|---|--|
| DUT_AD1   | Slip bit. This bit must equal the inverse of Bit D22 (that is, DUT_AD1).   |
| DUT_AD1, DUT_AD0                                    | Used in association with the external pins, AD1 and AD0, to determine which AD5758 device is being addressed by the system controller. Up to four unique devices can be addressed, corresponding to the DUT_AD1 and DUT_AD0 addresses of 0b00, 0b01, 0b10, and 0b11. |
| REG_ADR4, REG_ADR3, REG_ADR2,<br>REG_ADR1, REG_ADR0 | Selects which register is written to. See Table 26 for a summary of the available registers.   |

# **READING FROM REGISTERS**

The AD5758 has four options for readback mode that can be configured in the TWO\_STAGE\_READBACK\_SELECT register (see Table 44). These options are as follows:

- Two stage readback
- Autostatus readback
- Shared SYNC autostatus readback
- Echo mode

# Two Stage Readback Mode

Two stage readback mode consists of a write to the TWO\_ STAGE\_READBACK\_SELECT register to select the register location to be read back, followed by a NOP command. To perform a NOP command, write all zeros to Bits[D15:D0] of the NOP register. During the NOP command, the contents of the selected register are available on SDO in the format shown in Table 23. It is also possible to write a new two stage readback command during the second frame, such that the corresponding new data is available on SDO in the subsequent frame (see Figure 88). Bits[D31:D30] (or Bits[D23:D22], if SPI CRC is not enabled) = 0b10 are used as part of the synchronization during readback. The contents of the first write instruction to the TWO\_ STAGE\_READBACK\_SELECT register is shown in Table 24.

### Table 23. SDO Contents for Read Operation

| MSB        |                  |                  |           |  |  |  |
|------------|------------------|------------------|-----------|--|--|--|
| D23 to D22 | D21              | D20 to 16        | D15 to D0 |  |  |  |
| 0b10       | FAULT pin status | Register address | Data      |  |  |  |

# Table 24. Reading from a Register Using Two Stage Readback Mode MSB

| MSB     |         |         |      |     |     |          |     |          | LSB   |       |       |    |    |
|---------|---------|---------|------|-----|-----|----------|-----|----------|-------|-------|-------|----|----|
| D23     | D22     | D21     | D20  | D19 | D18 | D17      | D16 | [D15:D5] | D4    | D3    | D2    | D1 | D0 |
| DUT_AD1 | DUT_AD1 | DUT_AD0 | 0x13 |     |     | Reserved | RI  | EADBA    | ACK_S | ELECT | [4:0] |    |    |



Figure 88. Two Stage Readback Example

### Autostatus Readback Mode

If autostatus readback mode is selected, the contents of the status register are available on the SDO line during every SPI transaction. When reading back the status register, the SDO contents differ from the format shown in Table 23. The contents of the status register are shown in Table 25.

The autostatus readback mode can be used in conjunction with the ADC sequencer to consecutively monitor up to eight different ADC inputs. See the ADC Monitoring section for further details on the ADC sequencer. The autostatus readback mode can be configured via the READBACK\_MODE bits in the two stage readback select register (see the Two Stage Readback Select Register section).

# Table 25. SDO Contents for a Read Operation on the Status Register MSB



# Shared SYNC Autostatus Readback Mode

The shared SYNC autostatus readback is a special version of the autostatus readback mode used to avoid SDO bus contention when multiple AD5758 devices are sharing the same SYNC line (whereby AD5758 devices are distinguished from each other using the hardware address pins). After each valid write to a device, a flag is set. On the subsequent falling edge of SYNC, the flag is cleared. This mode behaves in a similar manner to the normal autostatus readback mode, except that the device does not output the status register contents on SDO when SYNC goes low, unless the internal flag is set (that is, the previous SPI write was valid). Refer to the example shown in Figure 90. The

shared SYNC autostatus readback mode can be configured via the READBACK\_MODE bits in the two stage readback select register (see the Two Stage Readback Select Register section).

#### Echo Mode

Echo mode behaves in a similar manner to the autostatus readback mode, except that every second readback consists of an echo of the previous command written to the AD5758. Echo mode is useful for checking which SPI instruction was received in the previous SPI frame. Echo mode can be configured via the READBACK\_MODE bits in the two stage readback select register (see the Two Stage Readback Select Register section).



# PROGRAMMING SEQUENCE TO ENABLE THE OUTPUT

To write to and set up the device from a power-on or reset condition, use the following procedure:

- 1. Perform a hardware or software reset and wait 100 µs.
- Perform a calibration memory refresh by writing 0xFCBA to the key register. Wait a minimum of 500 µs before proceeding to Step 3 to allow time for the internal calibrations to complete. As an alternative to waiting 500 µs for the refresh cycle to complete, poll the CAL\_MEM\_UNREFRESHED bit in the DIGITAL\_DIAG\_RESULTS register until it is 0.
- 3. Write 1 to Bit D13 in the DIGITAL\_DIAG\_RESULTS register to clear the RESET\_OCCURRED flag.
- 4. If CLKOUT is required, configure and enable this feature via the GP\_CONFIG1 register. It is important to configure this feature before enabling the dc-to-dc converter.
- Write to the DCDC\_CONFIG2 register to set the dc-to-dc current limit. Wait 300 µs to allow the 3-wire interface communication to complete. As an alternative to waiting 300 µs for the 3-wire interface communication to complete, poll the BUSY\_3WI bit in the DCDC\_CONFIG2 register until it is 0.
- 6. Write to the DCDC\_CONFIG1 register to set up the dc-to-dc converter mode (thereby enabling the dc-to-dc converter) and to close the fault protection switch (FPS). Wait 300 µs to allow the 3-wire interface communication to complete. As an alternative to waiting 300 µs to the 3-wire interface communication to complete, poll the BUSY\_3WI bit in the DCDC\_CONFIG2 register until it is 0.
- 7. Write to the DAC\_CONFIG register to set the INT\_EN bit (powers up the DAC and internal amplifiers without enabling the output) and configure the output range, internal/external R<sub>SET</sub>, and slew rate. Keep the OUT\_EN bit disabled at this point. Wait 500 µs minimum before proceeding to Step 8 to allow time for the internal calibrations to complete. As an alternative to waiting 500 µs for the refresh cycle to

complete, poll the CAL\_MEM\_ UNREFRESHED bit in the DIGITAL\_DIAG\_RESULTS register until it is 0.

- 8. Write zero-scale DAC code to the DAC\_INPUT register. (If a bipolar range was selected in Step 7, then a DAC code that represents a 0 mA/0 V output must be written to the DAC\_INPUT register). It is important that this step be completed even if the contents of the DAC\_INPUT register are not changing.
- 9. If LDAC functionality is being used, perform either a software or hardware LDAC command.
- Rewrite the same word to the DAC\_CONFIG register as in Step 7 except, this time, with the OUT\_EN bit enabled. Allow 1.25 ms minimum between Step 6 and Step 9; this is the time from when the dc-to-dc is enabled to when the VI<sub>OUT</sub> output is enabled.
- 11. Write the required DAC code to the DAC\_INPUT register.

An example configuration is shown in Figure 92.

#### Changing and Reprogramming the Range

After the output is enabled, use the following recommended steps when changing the output range:

- 1. Write to the DAC\_INPUT register. Set the output to 0 mA or 0 V.
- Write to the DAC\_CONFIG register. Disable the output (OUT\_EN = 0), and set the new output range. Keep the INT\_EN bit set. Wait 500 µs minimum before proceeding to Step 3 to allow time for internal calibrations to complete.
- 3. Write Code 0x0000 (in the case of bipolar ranges, write Code 0x8000) to the DAC\_INPUT register. It is important that this step be completed even if the contents of the DAC\_INPUT register are not changing.
- 4. Reload the DAC\_CONFIG register word from Step 2 except, this time, set the OUT\_EN bit to 1 to enable the output.
- 5. Write the required DAC code to the DAC\_INPUT register.

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EXAMPLE CONFIGURATION TO ENABLE THE OUTPUT CORRECTLY



Figure 92. Example Configuration to Enable the Output Correctly (CRC Disabled for Simplicity)

# **REGISTER DETAILS**

#### Table 26. Register Summary

| Address | Name                      | Description                                | Reset    | Access |
|---------|---------------------------|--|----------|--------|
| 0x00    | NOP                       | NOP register.                              | 0x000000 | R      |
| 0x01    | DAC_INPUT                 | DAC input register.                        | 0x010000 | R/W    |
| 0x02    | DAC_OUTPUT                | DAC output register.                       | 0x020000 | R      |
| 0x03    | CLEAR_CODE                | Clear code register.                       | 0x030000 | R/W    |
| 0x04    | USER_GAIN                 | User gain register.                        | 0x04FFFF | R/W    |
| 0x05    | USER_OFFSET               | User offset register.                      | 0x058000 | R/W    |
| 0x06    | DAC_CONFIG                | DAC configuration register.                | 0x060C00 | R/W    |
| 0x07    | SW_LDAC                   | Software LDAC register.                    | 0x070000 | R/W    |
| 0x08    | Кеу                       | Key register.                              | 0x080000 | R/W    |
| 0x09    | GP_CONFIG1                | General-Purpose Configuration 1 register.  | 0x090204 | R/W    |
| 0x0A    | GP_CONFIG2                | General-Purpose Configuration 2 register.  | 0x0A0200 | R/W    |
| 0x0B    | DCDC_CONFIG1              | DC-to-DC Configuration 1 register.         | 0x0B0000 | R/W    |
| 0x0C    | DCDC_CONFIG2              | DC-to-DC Configuration 2 register.         | 0x0C100  | R/W    |
| 0x0D    | Reserved                  | Reserved (do not write to this register).  | 0x0D0000 | R/W    |
| 0x0E    | Reserved                  | Reserved (do not write to this register).  | 0x0E0000 | R/W    |
| 0x0F    | WDT_CONFIG                | WDT configuration register.                | 0x0F0009 | R/W    |
| 0x10    | DIGITAL_DIAG_CONFIG       | Digital diagnostic configuration register. | 0x10005D | R/W    |
| 0x11    | ADC_CONFIG                | ADC configuration register.                | 0x110000 | R/W    |
| 0x12    | FAULT_PIN_CONFIG          | FAULT pin configuration register.          | 0x120000 | R/W    |
| 0x13    | TWO_STAGE_READBACK_SELECT | Two stage readback select register.        | 0x130000 | R/W    |
| 0x14    | DIGITAL_DIAG_RESULTS      | Digital diagnostic results register.       | 0x14A000 | R      |
| 0x15    | ANALOG_DIAG_RESULTS       | Analog diagnostic results register.        | 0x150000 | R      |
| 0x16    | Status                    | Status register.                           | 0x100000 | R      |
| 0x17    | CHIP_ID                   | Chip ID register.                          | 0x170101 | R      |
| 0x18    | FREQ_MONITOR              | Frequency monitor register.                | 0x180000 | R      |
| 0x19    | Reserved                  | Reserved.                                  | 0x190000 | R      |
| 0x1A    | Reserved                  | Reserved.                                  | 0x1A0000 | R      |
| 0x1B    | Reserved                  | Reserved.                                  | 0x1B0000 | R      |
| 0x1C    | DEVICE_ID_3               | Generic ID register.                       | 0x1C0000 | R      |

# NOP Register

### Address: 0x00, Reset: 0x000000, Name: NOP

Write 0x0000 to Bits[D15:D0] at this address to perform a no operation (NOP) command. Bits[15:0] of this register always read back as 0x0000.

#### Table 27. Bit Descriptions for NOP

| Bits    | Bit Name         | Description  | Reset | Access |
|---------|------------------|--|-------|--------|
| 21      | FAULT_PIN_STATUS | The FAULT_PIN_STATUS bit reflects the current status of the FAULT pin. | 0x0   | R      |
| [20:16] | REGISTER_ADDRESS | Register address.  | 0x0   | R      |
| [15:0]  | NOP command      | Write 0x0000 to perform a NOP command.                                 | 0x0   | R0/W   |

### **DAC Input Register**

#### Address: 0x01, Reset: 0x010000, Name: DAC\_INPUT

Bits[D15:D0] consists of the 16-bit data to be written to the DAC. If the  $\overline{\text{LDAC}}$  pin is tied low (that is, active), the DAC\_INPUT register contents are written directly to the DAC\_OUTPUT register without any  $\overline{\text{LDAC}}$  functionality dependence. If the  $\overline{\text{LDAC}}$  pin is tied high, the contents of the DAC\_INPUT register are written to the DAC\_OUTPUT register when the  $\overline{\text{LDAC}}$  pin is brought low or when the software  $\overline{\text{LDAC}}$  command is written.

#### Table 28. Bit Descriptions for DAC\_INPUT

| Bits    | Bit Name         | Description   | Reset | Access |
|---------|------------------|---|-------|--------|
| 21      | FAULT_PIN_STATUS | The FAULT_PIN_STATUS bit reflects the inverted current status of the FAULT pin. | 0x0   | R      |
| [20:16] | REGISTER_ADDRESS | Register address.   | 0x0   | R      |
| [15:0]  | DAC_INPUT_DATA   | DAC input data.   | 0x0   | R/W    |

#### **DAC Output Register**

#### Address: 0x02, Reset: 0x020000, Name: DAC\_OUTPUT

DAC\_OUTPUT is a read only register and contains the latest calibrated 16-bit DAC output value. If a clear event occurs due to a WDT fault, this register contains the clear code until the DAC is updated to another code.

| 1 4010 22 |                  |   |       |        |  |  |  |  |  |
|-----------|------------------|---|-------|--------|--|--|--|--|--|
| Bits      | Bit Name         | Description   | Reset | Access |  |  |  |  |  |
| 21        | FAULT_PIN_STATUS | The FAULT_PIN_STATUS bit reflects the inverted current status of the FAULT pin. | 0x0   | R      |  |  |  |  |  |
| [20:16]   | REGISTER_ADDRESS | Register address.   | 0x0   | R      |  |  |  |  |  |
| [15:0]    | DAC_OUTPUT_DATA  | DAC output data. For example, the last calibrated 16-bit DAC output value.      | 0x0   | R      |  |  |  |  |  |

#### Table 29. Bit Descriptions for DAC\_OUTPUT

#### Clear Code Register

#### Address: 0x03, Reset: 0x030000, Name: CLEAR\_CODE

When writing to the CLEAR\_CODE register, Bits[D15:D0] consist of the clear code to which the DAC clears on the occurrence of a clear event (for example, a WDT fault). After a clear event, the DAC\_INPUT register must be rewritten to with the 16-bit data to be written to the DAC, even if it is the same data as previously written before the clear event. Performing an LDAC write (either hardware or software) does not update the DAC\_OUTPUT register to a new code until the DAC\_INPUT register is first written to.

#### Table 30. Bit Descriptions for CLEAR\_CODE

| Bits    | Bit Name         | Description   | Reset | Access |
|---------|------------------|---|-------|--------|
| 21      | FAULT_PIN_STATUS | The FAULT_PIN_STATUS bit reflects the inverted current status of the FAULT pin.       | 0x0   | R      |
| [20:16] | REGISTER_ADDRESS | Register address.   | 0x0   | R      |
| [15:0]  | CLEAR_CODE       | Clear code. The DAC clears to this code upon a clear event, for example, a WDT fault. | 0x0   | R/W    |

### **User Gain Register**

#### Address: 0x04, Reset: 0x04FFFF, Name: USER\_GAIN

The 16-bit USER\_GAIN register allows the user to adjust the gain of the DAC channel in steps of 1 LSB. The USER\_GAIN register coding is straight binary. The default code is 0xFFFF. In theory, the gain can be tuned across the full range of the output. In practice, the maximum recommended gain trim is approximately 50% of the programmed range to maintain accuracy.

| Table 51: Die Descriptions for USER_GAIN |                  |   |        |        |  |  |
|--|------------------|---|--------|--------|--|--|
| Bits                                     | Bit Name         | Description   | Reset  | Access |  |  |
| 21                                       | FAULT_PIN_STATUS | The FAULT_PIN_STATUS bit reflects the inverted current status of the FAULT pin. | 0x0    | R      |  |  |
| [20:16]                                  | REGISTER_ADDRESS | Register address.   | 0x0    | R      |  |  |
| [15:0]                                   | USER_GAIN        | User gain correction code.  | 0xFFFF | R/W    |  |  |

# Table 31. Bit Descriptions for USER\_GAIN

### User Offset Register

#### Address: 0x05, Reset: 0x058000, Name: USER\_OFFSET

The 16-bit USER\_OFFSET register allows the user to adjust the offset of the DAC channel by -32,768 LSBs to +32,768 LSBs in steps of 1 LSB. The USER\_OFFSET register coding is straight binary. The default code is 0x8000, which results in zero offset programmed to the output.

#### Table 32. Bit Descriptions for USER\_OFFSET

| Bits    | Bit Name         | Description   | Reset  | Access |
|---------|------------------|---|--------|--------|
| 21      | FAULT_PIN_STATUS | The FAULT_PIN_STATUS bit reflects the inverted current status of the FAULT pin. | 0x0    | R      |
| [20:16] | REGISTER_ADDRESS | Register address.   | 0x0    | R      |
| [15:0]  | USER_OFFSET      | User offset correction code.  | 0x8000 | R/W    |

### DAC Configuration Register

#### Address: 0x06, Reset: 0x060C00, Name: DAC\_CONFIG

This register configures the DAC (range, internal/external R<sub>SET</sub>, and output enable), enables the output stage circuitry, and configures the slew rate control function.

| Bits    | Bit Name         | Description   | Reset | Access |
|---------|------------------|---|-------|--------|
| 21      | FAULT_PIN_STATUS | The FAULT_PIN_STATUS bit reflects the inverted current status of the FAULT pin.   | 0x0   | R      |
| [20:16] | REGISTER_ADDRESS | Register address.   | 0x0   | R      |
| [15:13] | SR_STEP          | Slew rate step. In conjunction with the slew rate clock, the slew rate step defines by<br>how much the output value changes at each update. Together, both parameters<br>define the rate of change of the output value.<br>000: 4 LSB (default).<br>001: 12 LSB.<br>010: 64 LSB.<br>011: 120 LSB.<br>100: 256 LSB.<br>101: 500 LSB.<br>110: 1820 LSB.<br>111: 2048 LSB. | 0x0   | R/W    |

#### Table 33. Bit Descriptions for DAC\_CONFIG

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| Bits   | Bit Name    | Description   | Reset | Access |
|--------|-------------|---|-------|--------|
| [12:9] | SR_CLOCK    | Slew rate clock. Slew rate clock defines the rate at which the digital slew is updated.   | 0x6   | R/W    |
|        |             | 0000: 240 kHz.  |       |        |
|        |             | 0001: 200 kHz.  |       |        |
|        |             | 0010: 150 kHz.  |       |        |
|        |             | 0011: 128 kHz.  |       |        |
|        |             | 0100: 64 kHz.   |       |        |
|        |             | 0101: 32 kHz.   |       |        |
|        |             | 0110: 16 kHz (default).   |       |        |
|        |             | 0111:8 kHz.   |       |        |
|        |             | 1000: 4 kHz.  |       |        |
|        |             | 1001: 2 kHz.  |       |        |
|        |             | 1010: 1 kHz.  |       |        |
|        |             | 1011: 512 Hz.   |       |        |
|        |             | 1100: 256 Hz.   |       |        |
|        |             | 1101: 128Hz.  |       |        |
|        |             | 1110: 64 Hz.  |       |        |
|        |             | 1111: 16 Hz.  |       |        |
| 8      | SR_EN       | Enable slew rate control.   | 0x0   | R/W    |
|        |             | 0: disable (default).   |       |        |
|        |             | 1: enable.  |       |        |
| 7      | RSET_EXT_EN | Enable external current setting resistor.   | 0x0   | R/W    |
|        |             | 0: select internal $R_{SET}$ resistor (default).  |       |        |
|        |             | 1: select external R <sub>SET</sub> resistor.   |       |        |
| 6      | OUT_EN      | Enable VI <sub>OUT</sub> .  | 0x0   | R/W    |
|        |             | 0: disable VI <sub>OUT</sub> output (default).  |       |        |
|        |             | 1: enable VI <sub>OUT</sub> output.   |       |        |
| 5      | INT_EN      | Enable internal buffers.  | 0x0   | R/W    |
|        |             | 0: disable (default).   |       |        |
|        |             | 1: enable. Setting this bit powers up the DAC and internal amplifiers. Setting this bit   |       |        |
|        |             | does not enable the output. It is recommended to set this bit and allow a >200 $\mu s$  |       |        |
|        |             | delay before enabling the output. This delay results in a reduced output enable glitch.   |       |        |
| 4      | OVRNG_EN    | Enable 20% voltage overrange.   | 0x0   | R/W    |
|        |             | 0: disable (default).   |       |        |
|        |             | 1: enable.  |       |        |
| [3:0]  | Range       | Select output range. Note that changing the contents of the range bits initiates an   | 0x0   | R/W    |
|        |             | internal calibration memory refresh and, therefore, a subsequent SPI write must not be  |       |        |
|        |             | performed until the CAL_MEM_UNREFRESHED bit in the DIGITAL_DIAG_RESULTS register returns to 0. Writes to invalid range codes are ignored. |       |        |
|        |             | 0000: 0 V to 5 V voltage range (default).   |       |        |
|        |             | 0001: 0 V to 10 V voltage range.  |       |        |
|        |             | $0010: \pm 5 \text{ V}$ voltage range.  |       |        |
|        |             | $0010. \pm 3$ V voltage range.<br>0011: ±10 V voltage range.  |       |        |
|        |             | 1000: 0 mA to 20 mA current range.  |       |        |
|        |             | -   |       |        |
|        |             | 1001: 0 mA to 24 mA current range.  |       |        |
|        |             | 1010: 4 mA to 20 mA current range.  |       |        |
|        |             | 1011: $\pm 20$ mA current range.  |       |        |
|        |             | 1100: $\pm 24$ mA current range.  |       |        |
|        | 1           | 1101: –1 mA to +22 mA current range.  | 1     | 1      |

### Software LDAC Register

#### Address: 0x07, Reset: 0x070000, Name: SW\_LDAC

Writing 0x1DAC to this register performs a software LDAC update on the device matching the DUT\_ADDRESS bits within the SPI frame. If the GLOBAL\_SW\_LDAC bit in the GP\_CONFIG2 register is set, the DUT\_ADDRESS bits are ignored and all devices sharing the same SPI bus are updated via the SW\_LDAC command. Bits[15:0] of this register always read back as 0x0000.

| Table 34. Bit Descriptions for SW_LDAC |
|--|
|--|

| Bits    | Bit Name         | Description  | Reset | Access |
|---------|------------------|--|-------|--------|
| 21      | FAULT_PIN_STATUS | The FAULT_PIN_STATUS bit reflects the inverted current status of the FAULT pin.      | 0x0   | R      |
| [20:16] | REGISTER_ADDRESS | Register address.  | 0x0   | R      |
| [15:0]  | LDAC_COMMAND     | Software LDAC. Write 0x1DAC to this register to perform a software LDAC instruction. | 0x0   | R0/W   |

### Key Register

#### Address: 0x08, Reset: 0x080000, Name: Key

This register accepts specific key codes to perform tasks such as calibration memory refresh and software reset. Bits[15:0] of this register always read back as 0x0000. All unlisted key codes are reserved.

#### Table 35. Bit Descriptions for Key

| Bits    | Bit Name         | Description   | Reset | Access |
|---------|------------------|---|-------|--------|
| 21      | FAULT_PIN_STATUS | The FAULT_PIN_STATUS bit reflects the inverted current status of the FAULT pin.   | 0x0   | R      |
| [20:16] | REGISTER_ADDRESS | Register address.   | 0x0   | R      |
| [15:0]  | KEY_CODE         | Key code.   | 0x0   | R0/W   |
|         |                  | 0x15FA: first of two keys to initiate a software reset.   |       |        |
|         |                  | 0xAF51: second of two keys to initiate a software reset.  |       |        |
|         |                  | 0x1ADC: key to initiate a single ADC conversion on the selected ADC channel.  |       |        |
|         |                  | 0x0D06: key to reset the WDT.   |       |        |
|         |                  | 0xFCBA: key to initiate a calibration memory refresh to the shadow registers. This key is only valid the first time it is run and has no effect if subsequent writes occur within a given system reset cycle. |       |        |

#### General-Purpose Configuration 1 Register

### Address: 0x09, Reset: 0x090204, Name: GP\_CONFIG1

This register is used to configure functions such as the temperature comparator threshold and CLKOUT, as well as enabling other miscellaneous features.

#### Table 36. Bit Descriptions for GP\_CONFIG1

| Bits    | Bit Name           | Description  | Reset | Access |
|---------|--------------------|--|-------|--------|
| 21      | FAULT_PIN_STATUS   | The FAULT_PIN_STATUS bit reflects the inverted current status of the FAULT pin.          | 0x0   | R      |
| [20:16] | REGISTER_ADDRESS   | Register address.  | 0x0   | R      |
| [15:14] | Reserved           | Reserved. (Do not alter the default value.)  | 0x0   | R      |
| [13:12] | SET_TEMP_THRESHOLD | Set the temperature comparator threshold value.  | 0x0   | R/W    |
|         |                    | 00: 142°C (default).   |       |        |
|         |                    | 01: 127°C.   |       |        |
|         |                    | 10: 112°C.   |       |        |
|         |                    | 11: 97℃.   |       |        |
| [11:10] | CLKOUT_CONFIG      | Configure the CLKOUT pin.  | 0x0   | R/W    |
|         |                    | 00: disable; no clock is output on the CLKOUT pin (default).                             |       |        |
|         |                    | 01: enable; clock is output on CLKOUT pin according to the CLKOUT_FREQ bits (Bits[2:0]). |       |        |
|         |                    | 10: reserved (do not select this option).  |       |        |
|         |                    | 11: reserved (do not select this option).  |       |        |

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| Bits  | Bit Name  | Description  | Reset | Access |
|-------|---|--|-------|--------|
| [9:7] | CLKOUT_FREQ   | Configure the frequency of CLKOUT.   | 0x4   | R/W    |
|       |   | 000: 416 kHz.  |       |        |
|       |   | 001: 435 kHz.  |       |        |
|       |   | 010: 454 kHz.  |       |        |
|       |   | 011: 476 kHz.  |       |        |
|       |   | 100: 500 kHz (default).  |       |        |
|       |   | 101: 526 kHz.  |       |        |
|       |   | 110: 555 kHz.  |       |        |
|       |   | 111: 588 kHz.  |       |        |
| 6     | HART_EN   | Enable the path to the C <sub>HART</sub> pin.  | 0x0   | R/W    |
|       |   | 0: output of the DAC drives the output stage directly (default).   |       |        |
|       |   | 1: CHART path is coupled to the DAC output to allow a HART modem connection or   |       |        |
|       |   | connection of a slew capacitor.  |       |        |
| 5     | NEG_OFFSET_EN   | Enable negative offset in unipolar $V_{OUT}$ mode. When set, this bit offsets the  | 0x0   | R/W    |
|       |   | currently enabled unipolar output range by the value listed here. This bit is only   |       |        |
|       |   | applicable to the 0 V to 6 V range and the 0 V to 12 V range. The 0 V to 6 V range   |       |        |
|       |   | becomes –300 mV to 5.7 V; the 0 V to 12 V range becomes –400 mV to 11.6 V.<br>0: disable (default).  |       |        |
|       |   | 1: enable.   |       |        |
|       |   |  |       | DAM    |
| 4     | CLEAR_NOW_EN  | Enables clear to occur immediately, even if the output slew feature is currently enabled.  | 0x0   | R/W    |
|       |   | 0: disable (default).  |       |        |
|       |   | 1: enable.   |       |        |
| 3     | SPI_DIAG_QUIET_EN   | Enable SPI diagnostic quiet mode. When this bit is enabled, SPI_CRC_ERR, SLIPBIT_ERR,  | 0x0   | R/W    |
|       |   | and SCLK_COUNT_ERR are not included in the logical OR calculation, which creates the DIG_DIAG_STATUS bit in the status register. They are also masked from affecting |       |        |
|       |   | the FAULT pin if this bit is set.  |       |        |
|       |   | 0: disable (default).  |       |        |
|       |   | 1: enable.   |       |        |
| 2     | OSC_STOP_DETECT_EN  | Enable automatic 0x07DEAD code on SDO if the internal oscillator (MCLK) stops.   | 0x1   | R/W    |
|       | · - · | 0: disable.  |       |        |
|       |   | 1: enable (default).   |       |        |
| 1     | Reserved  | Reserved. Do not alter the default value of this bit.  | 0x0   | R/W    |
| 0     | Reserved  | Reserved. Do not alter the default value of this bit.  | 0x0   | R/W    |
| ~     | incoch ved  |  | 0.00  | 14.44  |

# General-Purpose Configuration 2 Register

### Address: 0x0A, Reset: 0x0A0200, Name: GP\_CONFIG2

This register is used to configure and enable functions such as the voltage comparators, the internal current output monitor, and the global software LDAC.

| Bits    | Bit Name          | Description  | Reset | Access |
|---------|-------------------|--|-------|--------|
| 21      | FAULT_PIN_STATUS  | The FAULT_PIN_STATUS bit reflects the inverted current status of the FAULT pin.  | 0x0   | R      |
| [20:16] | REGISTER_ADDRESS  | Register address.  | 0x0   | R      |
| 15      | Reserved          | Reserved. Do not alter the default value if this bit.  | 0x0   | R0     |
| [14:13] | COMPARATOR_CONFIG | <ul> <li>Enable/disable the voltage comparator inputs for test purposes. The temperature comparator is permanently enabled. See the Background Supply and Temperature Monitoring section.</li> <li>00: disable voltage comparators (default).</li> <li>01: reserved.</li> <li>10: reserved.</li> <li>11: enable voltage comparators. The INT_EN bit in the DAC_CONFIG register must be set for the REFIN buffer to be powered up and this node available to the REFIN comparator.</li> </ul> | 0x0   | R/W    |

Table 37. Bit Descriptions for GP\_CONFIG2

| Bits  | Bit Name         | Description  | Reset | Access |
|-------|------------------|--|-------|--------|
| 12    | Reserved         | Reserved. (Do not alter the default value.)  | 0x0   | R/W    |
| 11    | INT_I_MONITOR_EN | Enable internal current monitor function.  | 0x0   | R/W    |
|       |                  | 0: disable (default).  |       |        |
|       |                  | 1: enable.   |       |        |
| 10    | GLOBAL_SW_LDAC   | When enabled, the DUT address bits are ignored when performing a software LDAC command, enabling multiple devices to be simultaneously updated using one SW_LDAC command.  | 0x0   | R/W    |
|       |                  | 0: disable (default).  |       |        |
|       |                  | 1: enable.   |       |        |
| 9     | FAULT_TIMEOUT    | Enable reduced fault detect timeout. This bit configures the delay from when the analog block indicates a $VI_{OUT}$ fault has been detected to the associated change of the relevant bit in the ANALOG_DIAG_RESULTS register. This feature provides flexibility to accommodate a variety of output load values. | 0x1   | R/W    |
|       |                  | 0: fault detect timeout = 25 ms.   |       |        |
|       |                  | 1: fault detect timeout = 6.5 ms (default).  |       |        |
| [8:5] | Reserved         | Reserved. Do not alter the default value of these bits.  | 0x0   | R/W    |
| 4     | Reserved         | Reserved. Do not alter the default value of this bit.  | 0x0   | R/W    |
| 3     | Reserved         | Reserved. Do not alter the default value of this bit.  | 0x0   | R/W    |
| 2     | Reserved         | Reserved. Do not alter the default value of this bit.  | 0x0   | R/W    |
| 1     | Reserved         | Reserved. Do not alter the default value of this bit.  | 0x0   | R/W    |
| 0     | Reserved         | Reserved. Do not alter the default value of this bit.  | 0x0   | R/W    |

# DC-to-DC Configuration 1 Register

### Address: 0x0B, Reset: 0x0B0000, Name: DCDC\_CONFIG1

This register is used to configure the dc-to-dc controller mode and enables/disables the  $\rm VI_{\rm OUT}$  fault protection switch.

| Bits    | Bit Name         | Description  | Reset | Access |
|---------|------------------|--|-------|--------|
| 21      | FAULT_PIN_STATUS | The FAULT_PIN_STATUS bit reflects the inverted current status of the FAULT pin.  | 0x0   | R      |
| [20:16] | REGISTER_ADDRESS | Register address.  | 0x0   | R      |
| [15:8]  | Reserved         | Reserved. Do not alter the default value of this bit.  | 0x0   | R0     |
| 7       | FAULT_PROT_SW_EN | Enable VIout fault protection switch.  | 0x0   | R/W    |
|         |                  | 0: disable, that is, fault protection switch is open (default).  |       |        |
|         |                  | 1: enable, that is, fault protection switch is closed.   |       |        |
| [6:5]   | DCDC_MODE        | These two bits configure the dc-to-dc converters.  | 0x0   | R/W    |
|         |                  | 00: dc-to-dc converter powered off (default).  |       |        |
|         |                  | 01: DPC current mode. The positive DPC rail tracks the headroom of the current output buffer.  |       |        |
|         |                  | 10: DPC voltage mode. The positive DPC rail is regulated to 15 V with respect to $-V_{\text{SENSE}}$ .   |       |        |
|         |                  | 11: PPC current mode. $V_{DPC+}$ is regulated to a user programmable level between 5.43 V and 28.48 V (depending on the DCDC_VPROG bits, Bits[4:0]) with respect to $-V_{SENSE}$ .   |       |        |
| [4:0]   | DCDC_VPROG       | DC-to-dc programmed voltage in PPC mode. $V_{DPC+}$ is regulated to a user programmable level between 5.43 V (0b00000) and 28.48 V (0b11111), in steps of 0.743 V. $V_{DPC+}$ is regulated with respect to $-V_{SENSE}$ . See Table 18 for an important note on the PPC current mode when selecting the $V_{SENSE}$ buffers as ADC inputs. | 0x0   | R/W    |

# DC-to-DC Configuration 2 Register

# Address: 0x0C, Reset: 0x0C0100, Name: DCDC\_CONFIG2

This register configures various dc-to-dc die features, such as the dc-to-dc converter current limit and the dc-to-dc die node, to be multiplexed to the ADC.

 Table 39. Bit Descriptions for DCDC\_CONFIG2

| FAULT pin.       FAULT pin.       FAULT pin.       FAULT pin.         [20:16]       REGISTER_ADDRESS       Register address.       0x0       R         [15:13]       Reserved.       Reserved. Do not alter the default value of these bits.       0x0       R         [12]       BUSY_3WI       Three-wire interface husy indicator.       0x0       R         [13]       Reserved.       Three-wire interface busy.       0x0       R         [14]       INTR_SAT_3WI       Three-wire interface busy.       0x0       R         [11]       INTR_SAT_3WI       Three-wire interface asturation flag. This flag is set to 1 when the interrupt detection circuitry is automatically disabled due to six consecutive interrupt setwire interface read and compare cycle. This read and compare cycle onfiguration registers on the main die match the contents of the copy of the dc-to-dc dc.       0x0       R         [9:8]       Reserved       Reserved and compare cycle (default).       0x1       R/W         [9:8]       Reserved.       Reserved. Do not alter the default value of these bits.       0x1       R/W         [9:8]       Reserved       Reserved. Do not alter the default.       0x0       R/W         [9:8]       Reserved.       Reserved.       Reserved.       0x1       R/W         [9:8]       Reserved.       Reserved.   | Bits    | Bit Name                     | Description   | Reset | Access |
|--|---------|------------------------------|---|-------|--------|
| [15:13]       Reserved       Reserved. Do not alter the default value of these bits.       0x0       R0         12       BUSY_3WI       Three-wire interface busy indicator.       0x0       R         12       BUSY_3WI       Three-wire interface busy indicator.       0x0       R         12       BUSY_3WI       Three-wire interface busy indicator.       0x0       R         13       Wire interface to currently active.       1: 3-wire interface busy.       0x1       R         11       INTR_SAT_3WI       Three-wire interface saturation flag. This flag is set to 1 when the interrupt detection circuitry is automatically disabled due to six consecutive interrupt signals. A write to either of the dc-to-dc       0x0       R         10       DCDC_READ_COMP_DIS       Disable 3-wire interface read and compare cycle. This read and compare cycle after each. 3-wire interface write.       0x0       R/W         11       :when set, this bit disables the automatic read and compare cycle after each. 3-wire interface write.       0x1       R/W         12       when set, this bit disables the automatic read and compare cycle after each. 3-wire interface write.       0x1       R/W         19:8]       Reserved       Reserved. Do not alter the default value of these bits.       0x1       R/W         19:8]       Reserved       Reserved. So resistor to ground on Vlour.       0x0 <t< td=""><td>21</td><td>FAULT_PIN_STATUS</td><td></td><td>0x0</td><td>R</td></t<>  | 21      | FAULT_PIN_STATUS             |   | 0x0   | R      |
| 12       BUSY_3WI       Three-wire interface busy indicator.<br>0: 3-wire interface not currently active.<br>1: 3-wire interface busy.       0x0       R         11       INTR_SAT_3WI       Three-wire interface saturation flag. This flag is set to 1 when the<br>interrupt detection circuitry is automatically disabled due to six<br>consecutive interrupt signals. A write to either of the dc-to-dc<br>configuration registers clears this bit to 0.       0x0       R         10       DCDC_READ_COMP_DIS       Disable 3-wire interface read and compare cycle. This read and compare<br>cycle ensures that the contents of the dc-to-dc configuration<br>registers on the main die match the contents on the dc-to-dc die.<br>0: enable automatic read and compare cycle (default).<br>1: when set, this bit disables the automatic read and compare cycle<br>after each 3-wire interface write.       0x0       R/W         [9:8]       Reserved       Reserved. Do not alter the default value of these bits.       0x1       R/W         6       VIOUT_PULLDOWN_EN       Enable short deglitch time or VIowr fault protection switch error flag.<br>0: disable (default).       0x0       R/W         [5:4]       DCDC_ADC_CONTROL_DIAG       Select which dc-to-dc die.<br>01: internal 2.5 V supply on dc-to-dc die.<br>01: 200  | [20:16] | REGISTER_ADDRESS             | Register address.   | 0x0   | R      |
| 0: 3-wire interface not currently active.       1:3-wire interface busy.         11       INTR_SAT_3WI       Three-wire interface saturation flag. This flag is set to 1 when the interrupt detection circuitry is automatically disabled due to six consecutive interrupt signals. A write to either of the dc-to-dc configuration registers clears this bit to 0.       0x0       R         10       DCDC_READ_COMP_DIS       Disable 3-wire interface read and compare cycle. This read and compare cycle after each 3-wire interface read and compare cycle (default).       0x0       R/W         11       When set, this bit disables the automatic read and compare cycle after each 3-wire interface write.       0x0       R/W         12       Reserved       Reserved.on on tater the default value of these bits.       0x1       R/W         13       WIOUT_PULLDOWN_EN       Enable short deglitch time set to 1.02 ms (default).       0x0       R/W         14: enable.       0: disable (default).       1: deglitch time set to 1.28 us.       0x1       R/W         6       VIOUT_PULLDOWN_EN       Enable 18:00 (Default).       0: disable (default). <td< td=""><td>[15:13]</td><td>Reserved</td><td>Reserved. Do not alter the default value of these bits.</td><td>0x0</td><td>RO</td></td<>   | [15:13] | Reserved                     | Reserved. Do not alter the default value of these bits.   | 0x0   | RO     |
| 1: 3-wire interface busy.       Image: Second                        | 12      | BUSY_3WI                     | Three-wire interface busy indicator.  | 0x0   | R      |
| 11       INTR_SAT_3WI       Three-wire interface saturation flag. This flag is set to 1 when the interrupt detection circuitry is automatically disabled due to six consecutive interrupt signals. A write to either of the dc-to-dc configuration registers clears this bit to 0.       0x0       R         10       DCDC_READ_COMP_DIS       Disable 3-wire interface read and compare cycle default).       0x0       R/W         11       INTR_SAT_3WI       Disable 3-wire interface read and compare cycle default).       0x0       R/W         10       DCDC_READ_COMP_DIS       Disable 3-wire interface read and compare cycle default).       0x0       R/W         11  |         |                              | 0: 3-wire interface not currently active.   |       |        |
| and and a set of the set              |         |                              | 1: 3-wire interface busy.   |       |        |
| second              | 11      | INTR_SAT_3WI                 | interrupt detection circuitry is automatically disabled due to six consecutive interrupt signals. A write to either of the dc-to-dc   | 0x0   | R      |
| [9:8]       Reserved       Reserved. Do not alter the default value of these bits.       0x1       R/W         7       FAULT_PROT_SW_SHORT_DEGLITCH       Enable short deglitch time on Vlour fault protection switch error flag.<br>0: deglitch time set to 1.02 ms (default).<br>1: deglitch time set to 128 us.       0x0       R/W         6       VIOUT_PULLDOWN_EN       Enable the 30 kΩ resistor to ground on Vlour.<br>0: disable (default).<br>1: enable.       0x0       R/W         [5:4]       DCDC_ADC_CONTROL_DIAG       Select which dc-to-dc die node is multiplexed to the ADC on the<br>main die.<br>00: AGND on dc-to-dc die.<br>01: internal 2.5 V supply on dc-to-dc die.<br>10: AV <sub>DO1</sub> .       0x0       R/W         [3:1]       DCDC_LLIMIT       These three bits set the dc-to-dc converter current limit.<br>00: 250 mA.<br>011: 300 mA.<br>100: 350 mA.<br>101: 400 mA.<br>110: 400 mA.<br>111: 400 mA.       0x0       R/W   | 10      | DCDC_READ_COMP_DIS           | <ul> <li>cycle ensures that the contents of the copy of the dc-to-dc configuration registers on the main die match the contents on the dc-to-dc die.</li> <li>0: enable automatic read and compare cycle (default).</li> <li>1: when set, this bit disables the automatic read and compare cycle</li> </ul> | 0x0   | R/W    |
| 7       FAULT_PROT_SW_SHORT_DEGLITCH       Enable short deglitch time on Vlour fault protection switch error flag.<br>0: deglitch time set to 1.02 ms (default).<br>1: deglitch time set to 128 us.       0x0       R/W         6       VIOUT_PULLDOWN_EN       Enable the 30 kΩ resistor to ground on Vlout.<br>0: disable (default).<br>1: enable.       0x0       R/W         [5:4]       DCDC_ADC_CONTROL_DIAG       Select which dc-to-dc die node is multiplexed to the ADC on the<br>main die.<br>00: AGND on dc-to-dc die.<br>01: internal 2.5 V supply on dc-to-dc die.<br>10: AV <sub>DD1</sub> .<br>11: reserved (do not select this option).       0x0       R/W         [3:1]       DCDC_ILIMIT       These three bits set the dc-to-dc converter current limit.<br>00: 350 mA.<br>100: 350 mA.<br>100: 350 mA.<br>110: 400 mA.<br>111: 400 mA.       0x0       R/W   |         |                              |   |       |        |
| 0: deglitch time set to 1.02 ms (default).<br>1: deglitch time set to 128 us.0:6VIOUT_PULLDOWN_ENEnable the 30 kΩ resistor to ground on Vlour.<br>0: disable (default).<br>1: enable.0x0R/W[5:4]DCDC_ADC_CONTROL_DIAGSelect which dc-to-dc die node is multiplexed to the ADC on the<br>main die.<br>00: AGND on dc-to-dc die.<br>01: internal 2.5 V supply on dc-to-dc die.<br>10: AVpp1.<br>11: reserved (do not select this option).0x0R/W[3:1]DCDC_ILLIMITThese three bits set the dc-to-dc converter current limit.<br>001: 200 mA.<br>010: 250 mA.<br>101: 400 mA.<br>110: 400 mA.<br>110: 400 mA.0x0R/W   |         |                              |   | -     |        |
| 6       VIOUT_PULLDOWN_EN       Enable the 30 kΩ resistor to ground on Vlout.<br>0: disable (default).<br>1: enable.       0x0       R/W         [5:4]       DCDC_ADC_CONTROL_DIAG       Select which dc-to-dc die node is multiplexed to the ADC on the<br>main die.<br>00: AGND on dc-to-dc die.<br>01: internal 2.5 V supply on dc-to-dc die.<br>10: AV <sub>DD1</sub> .<br>11: reserved (do not select this option).       0x0       R/W         [3:1]       DCDC_ILIMIT       These three bits set the dc-to-dc converter current limit.<br>00: 150 mA.<br>010: 250 mA.<br>011: 300 mA.<br>100: 350 mA.<br>110: 400 mA.<br>111: 400 mA.<br>111: 400 mA.       0x0       R/W   | 7       | FAULT_PROT_SW_SHORT_DEGLITCH | 0: deglitch time set to 1.02 ms (default).  | 0x0   | R/W    |
| 0: disable (default).<br>1: enable.0: disable (default).<br>1: enable.0: disable (default).<br>1: enable.[5:4]DCDC_ADC_CONTROL_DIAGSelect which dc-to-dc die node is multiplexed to the ADC on the<br>main die.<br>00: AGND on dc-to-dc die.<br>01: internal 2.5 V supply on dc-to-dc die.<br>10: AV_DD1.<br>11: reserved (do not select this option).0x0R/W[3:1]DCDC_ILIMITThese three bits set the dc-to-dc converter current limit.<br>000: 150 mA (default).<br>001: 200 mA.<br>010: 250 mA.<br>011: 300 mA.<br>101: 300 mA.<br>101: 400 mA.<br>111: 400 mA.<br>111: 400 mA.0x0R/W   | 6       | VIOUT_PULLDOWN_EN            | -   | 0x0   | R/W    |
| [5:4]DCDC_ADC_CONTROL_DIAGSelect which dc-to-dc die node is multiplexed to the ADC on the<br>main die.<br>00: AGND on dc-to-dc die.<br>01: internal 2.5 V supply on dc-to-dc die.<br>10: AV_DD1.<br>11: reserved (do not select this option).0x0R/W[3:1]DCDC_ILIMITThese three bits set the dc-to-dc converter current limit.<br>000: 150 mA (default).<br>01: 250 mA.<br>010: 250 mA.<br>101: 300 mA.<br>101: 300 mA.<br>101: 400 mA.<br>111: 400 mA.<br>111: 400 mA.0x0R/W   |         |                              | 0: disable (default).   |       |        |
| main die.<br>00: AGND on dc-to-dc die.<br>01: internal 2.5 V supply on dc-to-dc die.<br>10: AV <sub>DD1</sub> .<br>11: reserved (do not select this option).Image: select disconserved |         |                              | 1: enable.  |       |        |
| 000: 150 mA (default).<br>001: 200 mA.<br>010: 250 mA.<br>011: 300 mA.<br>100: 350 mA.<br>101: 400 mA.<br>110: 400 mA.<br>111: 400 mA.   | [5:4]   |                              | main die.<br>00: AGND on dc-to-dc die.<br>01: internal 2.5 V supply on dc-to-dc die.<br>10: AV <sub>DD1</sub> .   | 0x0   | R/W    |
| 0 Reserved Reserved. Do not alter the default value of this bit. 0x0 R/W   | [3:1]   | DCDC_ILIMIT                  | 000: 150 mA (default).<br>001: 200 mA.<br>010: 250 mA.<br>011: 300 mA.<br>100: 350 mA.<br>101: 400 mA.<br>110: 400 mA.  | 0x0   | R/W    |
|  | 0       | Reserved                     | Reserved. Do not alter the default value of this bit.   | 0x0   | R/W    |

# Watchdog Timer (WDT) Configuration Register

# Address: 0x0F, Reset: 0x0D0009, Name: WDT\_CONFIG

This register configures the WDT timeout values. This register also configures the WDT setup in terms of acceptable resets and the resulting response to a WDT fault (for example, clear the output or reset the device).

| Bits    | Bit Name            | Description  | Reset | Access |
|---------|---------------------|--|-------|--------|
| 21      | FAULT_PIN_STATUS    | The FAULT_PIN_STATUS bit reflects the inverted current status of the FAULT pin.  | 0x0   | R      |
| [20:16] | REGISTER_ADDRESS    | Register address.  | 0x0   | R      |
| [15:11] | Reserved            | Reserved. Do not alter the default value of these bits.  | 0x0   | R      |
| 10      | CLEAR_ON_WDT_FAIL   | Enable clear on WDT fault. If the WDT times out, a clear event occurs, whereby the output is loaded with the clear code stored in the CLEAR_CODE register.<br>0: disable (default).<br>1: enable.  | 0x0   | R/W    |
| 9       | RESET_ON_WDT_FAIL   | Enable a software reset to automatically occur if the WDT times out.<br>0: disable (default).<br>1: enable.  | 0x0   | R/W    |
| 8       | KICK_ON_VALID_WRITE | Enable any valid SPI command to reset the WDT. Any active WDT error flags must<br>be cleared before the WDT can be restarted.<br>0: disable (default).<br>1: enable.   | 0x0   | R/W    |
| 7       | Reserved            | Reserved. Do not alter the default value of this bit.  | 0x0   | R/W    |
| 6       | WDT_EN              | Enables the WDT, then starts the WDT, assuming there are no active WDT fault flags.<br>0: disable (default).<br>1: enable.   | 0x0   | R/W    |
| [5:4]   | Reserved            | Reserved. Do not alter the default value of these bits.  | 0x0   | R/W    |
| [3:0]   | WDT_TIMEOUT         | Set the WDT timeout value. Setting WDT_TIMEOUT to a binary value beyond<br>0b1010 results in the default setting of 1 sec.<br>0000: 1 ms.<br>0001: 5 ms.<br>0010: 10 ms.<br>0011: 25 ms.<br>0100: 50 ms.<br>0101: 100 ms.<br>0111: 500 ms.<br>0111: 500 ms.<br>1000: 750 ms.<br>1001: 1 sec (default).<br>1010: 2 sec. | 0x9   | R/W    |

### Table 40. Bit Descriptions for WDT\_CONFIG

#### Digital Diagnostic Configuration Register

#### Address: 0x10, Reset: 0x10005D, Name: DIGITAL\_DIAG\_CONFIG

This register configures various digital diagnostic features of interest for a particular application.

| Bits    | Bit Name             | Description  | Reset | Access |
|---------|----------------------|--|-------|--------|
| 21      | FAULT_PIN_STATUS     | The FAULT_PIN_STATUS bit reflects the inverted current status of the FAULT pin.  | 0x0   | R      |
| [20:16] | REGISTER_ADDRESS     | Register address.  | 0x0   | R      |
| [15:9]  | Reserved             | Reserved. Do not alter the default value of these bits.  | 0x0   | RO     |
| [8:7]   | Reserved             | Reserved. Do not alter the default value of these bits.  | 0x0   | R/W    |
| 6       | DAC_LATCH_MON_EN     | Enable a diagnostic monitor on the DAC latches. This feature monitors the actual digital code driving the DAC and compares it with the digital code generated within the digital block. Any difference between the two codes causes the DAC_LATCH_MON_ERR flag to be set in the DIGITAL_DIAG_RESULTS register. | 0x1   | R/W    |
|         |                      | 0: disable.  |       |        |
|         |                      | 1: enable (default).   |       |        |
| 5       | Reserved             | Reserved. Do not alter the default value of this bit.  | 0x0   | R/W    |
| 4       | INVERSE_DAC_CHECK_EN | Enable check for DAC code vs. inverse DAC code error.  | 0x1   | R/W    |
|         |                      | 0: disable.  |       |        |
|         |                      | 1: enable (default).   |       |        |
| 3       | CAL_MEM_CRC_EN       | Enable CRC of calibration memory on a calibration memory refresh.  | 0x1   | R/W    |
|         |                      | 0: disable.  |       |        |
|         |                      | 1: enable (default).   |       |        |
| 2       | FREQ_MON_EN          | Enable the internal frequency monitor on the internal oscillator (MCLK).   | 0x1   | R/W    |
|         |                      | 0: disable.  |       |        |
|         |                      | 1: enable (default).   |       |        |
| 1       | Reserved             | Reserved. Do not alter the default value of this bit.  | 0x0   | R/W    |
| 0       | SPI_CRC_EN           | Enable SPI CRC function.   | 0x1   | R/W    |
|         |                      | 0: disable.  |       |        |
|         |                      | 1: enable (default).   |       |        |

#### Table 41. Bit Descriptions for DIGITAL\_DIAG\_CONFIG

### ADC Configuration Register

#### Address: 0x11, Reset: 0x110000, Name: ADC\_CONFIG

This register configures the ADC into one of four modes of operation: key sequencing, automatic sequencing, single immediate conversion of the currently selected ADC\_IP\_SELECT node, or single-key conversion.

| Table 42. Bit Descriptions for ADC_CONFIG | Table 42 | Bit Descri | ptions for | ADC | CONFIG |
|---|----------|------------|------------|-----|--------|
|---|----------|------------|------------|-----|--------|

| Bits    | Bit Name         | Description   | Reset | Access |
|---------|------------------|---|-------|--------|
| 21      | FAULT_PIN_STATUS | The FAULT_PIN_STATUS bit reflects the inverted current status of the FAULT pin. | 0x0   | R      |
| [20:16] | REGISTER_ADDRESS | Register address. (Do not alter the default value.)                             | 0x0   | R      |
| [15:11] | Reserved         | Reserved.   | 0x0   | R/W    |

| Bits   | Bit Name         | Description   | Reset | Access |
|--------|------------------|---|-------|--------|
| [10:8] | SEQUENCE_COMMAND | ADC sequence command bits.  | 0x0   | R/W    |
|        |                  | 000: set the depth of the sequencer. The contents of the SEQUENCE_DATA bits correspond to the depth of the sequencer ( $000 = 1$ channel, $001 = 2$ channels,, $111 = 8$ channels).   |       |        |
|        |                  | 001: set the channel SEQUENCE_DATA[2:0] with the ADC input, ADC_IP_SELECT[4:0].   |       |        |
|        |                  | 010: enable/disable key sequencer mode, depending on the contents of the SEQUENCE_DATA[2:0] bits. SEQUENCE_DATA[2:0] = 001: enables the key sequencer. SEQUENCE_DATA[2:0] $\neq$ 001: disables the key sequencer.                   |       |        |
|        |                  | 011: enable/disable automatic sequencer mode, depending on the contents of the SEQUENCE_DATA[2:0] bits. SEQUENCE_DATA[2:0] = 001: enables the automatic sequencer. SEQUENCE_DATA[2:0] $\neq$ 001: disables the automatic sequencer. |       |        |
|        |                  | 100: initiate a single conversion on the ADC_IP_SELECT (Bits[4:0]) input; this disables autosequencing. The SEQUENCE_DATA bits, Bits[2:0], are not applicable for this command.   |       |        |
|        |                  | 101: set up the ADC for future individual ADC conversions (if not using the key sequencer) using the 0x1ADC key code. The SEQUENCE_DATA bits, Bits[2:0], are not applicable for this command.                                       |       |        |
|        |                  | 110: reserved (do not select this option).  |       |        |
|        |                  | 111: reserved (do not select this option).  |       |        |
| [7:5]  | SEQUENCE_DATA    | The function of the contents of this field is dependent on the command being issued by the SEQUENCE_COMMAND bits.   | 0x0   | R/W    |
| [4:0]  | ADC_IP_SELECT    | Select which node to multiplex to the ADC. All unlisted 5-bit codes are reserved  | 0x0   | R/W    |
|        |                  | and return an ADC result of zero.   |       |        |
|        |                  | 00000: main die temperature.  |       |        |
|        |                  | 00001: dc-to-dc die temperature.  |       |        |
|        |                  | 00010: reserved (do not select this option).  |       |        |
|        |                  | 00011: REFIN. The INT_EN bit in the DAC_CONFIG register must be set for the REFIN buffer to be powered up and this node to be available to the ADC.   |       |        |
|        |                  | 00100: REF2; internal 1.23 V reference voltage.   |       |        |
|        |                  | 00101: reserved (do not select this option).  |       |        |
|        |                  | 00110: reserved (do not select this option).  |       |        |
|        |                  | 01100: reserved (do not select this option).  |       |        |
|        |                  | 01101: voltage on the +V <sub>SENSE</sub> buffer output.  |       |        |
|        |                  | 01110: voltage on the –V <sub>SENSE</sub> buffer output   |       |        |
|        |                  | 10000: reserved (do not select this option).  |       |        |
|        |                  | 10001: reserved (do not select this option).  |       |        |
|        |                  | 10010: reserved (do not select this option).  |       |        |
|        |                  | 10011: reserved (do not select this option).  |       |        |
|        |                  | 10100: INT_AVCC.  |       |        |
|        |                  | 10101: V <sub>LDO.</sub>  |       |        |
|        |                  | 10110: V <sub>LOGIC</sub> .   |       |        |
|        |                  | 10111: Internal current monitor output voltage. The output range of this node is 0 V to 2 V.  |       |        |
|        |                  | 11000: REFGND.  |       |        |
|        |                  | 11001: AGND.  |       |        |
|        |                  | 11010: DGND.  |       |        |
|        |                  | 11011: V <sub>DPC+</sub> .  |       |        |
|        |                  | 11100: AV <sub>DD2</sub> .  |       |        |
|        |                  | 11101: AV <sub>ss</sub> .   |       |        |
|        |                  | 11110: dc-to-dc die node; configured in the DCDC_CONFIG2 register.<br>11111: REFOUT.  |       |        |

# FAULT Pin Configuration Register

# Address: 0x12, Reset: 0x120000, Name: FAULT\_PIN\_CONFIG

This register is used to mask particular fault bits from the FAULT pin, if so desired.

| Bits    | Bit Name               | Description  | Reset | Access |
|---------|------------------------|--|-------|--------|
| 21      | FAULT_PIN_STATUS       | The FAULT_PIN_STATUS bit reflects the inverted current status of the FAULT pin.                      | 0x0   | R      |
| [20:16] | REGISTER_ADDRESS       | Register address.  | 0x0   | R      |
| 15      | INVALID_SPI_ACCESS_ERR | If this bit is set, do not map the INVALID_SPI_ACCESS_ERR fault flag to the FAULT pin.               | 0x0   | R/W    |
| 14      | FAULT_PROT_SW_ERR      | If this bit is set, do not map the FAULT_PROT_SW_ERR fault flag to the FAULT pin.                    | 0x0   | R/W    |
| 13      | Reserved               | Reserved. Do not alter the default value of this bit.  | 0x0   | R/W    |
| 12      | INVERSE_DAC_CHECK_ERR  | If this bit is set, do not map the INVERSE_DAC_CHECK_ERR flag to the FAULT pin.                      | 0x0   | R/W    |
| 11      | Reserved               | Reserved. Do not alter the default value of this bit.  | 0x0   | R/W    |
| 10      | OSCILLATOR_STOP_DETECT | If this bit is set, do not map the clock stop error to the FAULT pin.                                | 0x0   | R/W    |
| 9       | DAC_LATCH_MON_ERR      | If this bit is set, do not map the DAC_LATCH_MON_ERR fault flag to the FAULT pin.                    | 0x0   | R/W    |
| 8       | WDT_ERR                | If this bit is set, do not map the WDT_ERR flag to the FAULT pin.                                    | 0x0   | R/W    |
| 7       | SLIPBIT_ERR            | If this bit is set, do not map the SLIPBIT_ERR error flag to the FAULT pin.                          | 0x0   | R/W    |
| 6       | SPI_CRC_ERR            | If this bit is set, do not map the SPI_CRC_ERR error flag to the pin.                                | 0x0   | R/W    |
| 5       | Reserved               | Reserved. Do not alter the default value of this bit.  | 0x0   | R/W    |
| 4       | DCDC_P_SC_ERR          | If this bit is set, do not map the positive rail dc-to-dc short circuit error flag to the FAULT pin. | 0x0   | R/W    |
| 3       | IOUT_OC_ERR            | If this bit is set, do not map the current output open-circuit error flag to the FAULT pin.          | 0x0   | R/W    |
| 2       | VOUT_SC_ERR            | If this bit is set, do not map the voltage output short-circuit error flag to the FAULT pin.         | 0x0   | R/W    |
| 1       | Reserved               | Reserved. Do not alter the default value of this bit.  | 0x0   | R/W    |
| 0       | MAIN_DIE_TEMP_ERR      | If this bit is set, do not map the main die temperature error flag to the FAULT pin.                 | 0x0   | R/W    |

# Table 43. Bit Descriptions for FAULT\_PIN\_CONFIG

#### Two Stage Readback Select Register

#### Address: 0x13, Reset: 0x130000, Name: TWO\_STAGE\_READBACK\_SELECT

This register selects the address of the register required for a two stage readback operation. The address of the register selected for readback is stored in Bits[D4:D0].

| Bits    | Bit Name         | Description   | Reset | Access |
|---------|------------------|---|-------|--------|
| 21      | FAULT_PIN_STATUS | The FAULT_PIN_STATUS bit reflects the inverted current status of the FAULT pin.   | 0x0   | R      |
| [20:16] | REGISTER_ADDRESS | Register address.   | 0x0   | R      |
| [15:7]  | Reserved         | Reserved.   | 0x0   | R      |
| [6:5]   | READBACK_MODE    | These bits control the SPI readback mode.   | 0x0   | R/W    |
|         |                  | 0: two stage SPI readback mode (default).   |       |        |
|         |                  | 01: autostatus readback mode: the status register contents are shifted out on SDO for every SPI frame.  |       |        |
|         |                  | 10: shared SYNC autostatus readback mode. This mode allows the use of a shared SYNC line on multiple devices (distinguished using the hardware address pins). After each valid write to a device, a flag is set. This mode behaves similar to the normal autostatus readback mode, except that the device does not output the status register contents on SDO as SYNC goes low, unless the internal flag is set (that is, the previous SPI write is valid). |       |        |
|         |                  | 11: the status register contents and the previous SPI frame instruction are alternately available on SDO.   |       |        |

#### Table 44. Bit Descriptions for TWO\_STAGE\_READBACK\_SELECT

| Bits  | Bit Name        | Description                                       | Reset | Access |
|-------|-----------------|---|-------|--------|
| [4:0] | READBACK_SELECT | Select readback address for a two stage readback. | 0x0   | R/W    |
|       |                 | 0x00: NOP register (default).                     |       |        |
|       |                 | 0x01: DAC_INPUT register.                         |       |        |
|       |                 | 0x02: DAC_OUTPUT register.                        |       |        |
|       |                 | 0x03: CLEAR_CODE register.                        |       |        |
|       |                 | 0x04: USER_GAIN register.                         |       |        |
|       |                 | 0x05: USER_OFFSET register.                       |       |        |
|       |                 | 0x06: DAC_CONFIG register.                        |       |        |
|       |                 | 0x07: SW_LDAC register.                           |       |        |
|       |                 | 0x08: key register.                               |       |        |
|       |                 | 0x09: GP_CONFIG1 register.                        |       |        |
|       |                 | 0x0A: GP_CONFIG2 register.                        |       |        |
|       |                 | 0x0B: DCDC_CONFIG1 register.                      |       |        |
|       |                 | 0x0C: DCDC_CONFIG2 register.                      |       |        |
|       |                 | 0x0D: reserved (do not select this option).       |       |        |
|       |                 | 0x0E: reserved (do not select this option).       |       |        |
|       |                 | 0x0F: WDT_CONFIG register.                        |       |        |
|       |                 | 0x10: DIGITAL_DIAG_CONFIG register.               |       |        |
|       |                 | 0x11: ADC_CONFIG register.                        |       |        |
|       |                 | 0x12: FAULT_PIN_CONFIG register.                  |       |        |
|       |                 | 0x13: TWO_STAGE_READBACK_SELECT register.         |       |        |
|       |                 | 0x14: DIGITAL_DIAG_RESULTS register.              |       |        |
|       |                 | 0x15: ANALOG_DIAG_RESULTS register.               |       |        |
|       |                 | 0x16: status register.                            |       |        |
|       |                 | 0x17: CHIP_ID register.                           |       |        |
|       |                 | 0x18: FREQ_MONITOR register.                      |       |        |
|       |                 | 0x19: reserved (do not select this option).       |       |        |
|       |                 | 0x1A: reserved (do not select this option).       |       |        |
|       |                 | 0x1B: reserved (do not select this option).       |       |        |
|       |                 | 0x1C: DEVICE_ID_3 register.                       |       |        |

# Digital Diagnostic Results Register

# Address: 0x14, Reset: 0x14A000, Name: DIGITAL\_DIAG\_RESULTS

This register contains an error flag for the on-chip digital diagnostic features, most of which are configurable using the digital diagnostic configuration register. This register also contains a flag to indicate that a reset occurred, as well as a flag to indicate that the calibration memory has not refreshed or an invalid SPI access attempted. With the exception of the CAL\_MEM\_UNREFRESHED and SLEW\_BUSY flags, all of these flags require a 1 to be written to them to update them to their current value. The CAL\_MEM\_UNREFRESHED and SLEW\_BUSY flags automatically clear when the calibration memory refresh or output slew, respectively, is complete. When the corresponding enable bits in the DIGITAL\_DIAG\_CONFIG register are not enabled, the respective flag bits read as zero.

| Bits    | Bit Name            | Description   | Reset | Access |
|---------|---------------------|---|-------|--------|
| 21      | FAULT_PIN_STATUS    | The FAULT_PIN_STATUS bit reflects the inverted current status of the FAULT pin.   | 0x0   | R      |
| [20:16] | REGISTER_ADDRESS    | Register address.   | 0x0   | R      |
| 15      | CAL_MEM_UNREFRESHED | Calibration memory unrefreshed flag. Note that modifying the range bits in the DAC_CONFIG register also initiates a calibration memory refresh, which asserts this bit. Unlike the R/W-1-C bits in this register, this bit is automatically cleared after the calibration memory refresh completes. | 0x1   | R      |
|         |                     | 0: calibration memory is refreshed.<br>1: calibration memory is unrefreshed (default on power-up). Note that this<br>bit asserts if the range bits are modified in the DAC_CONFIG register.   |       |        |
| 14      | SLEW_BUSY           | This flag is set to 1 when the DAC is actively slewing. Unlike the R/W-1-C bits in this register, this bit is automatically cleared when slewing is complete.   | 0x0   | R      |

Table 45. Bit Descriptions for DIGITAL\_DIAG\_RESULTS

| Bits | Bit Name               | Description  | Reset | Access  |
|------|------------------------|--|-------|---------|
| 13   | RESET_OCCURRED         | This bit flags that a reset occurred (default on power-up is therefore Logic 1).   | 0x1   | R/W-1-C |
| 12   | ERR_3WI                | This bit flags an error in the interdie 3-wire interface communications.   | 0x0   | R/W-1-C |
| 11   | WDT_ERR                | This bit flags a WDT fault.  | 0x0   | R/W-1-C |
| 10   | Reserved               | Reserved.  | 0x0   | R/W-1-C |
| 9    | 3WI_RC_ERR             | This bit flags an error if the 3-wire read and compare process is enabled and a parity error occurs.   | 0x0   | R/W-1-C |
| 8    | DAC_LATCH_MON_ERR      | This bit flags if the output of the DAC latches does not match the input.  | 0x0   | R/W-1-C |
| 7    | Reserved               | Reserved.  | 0x0   | R/W-1-C |
| 6    | INVERSE_DAC_CHECK_ERR  | This bit flags if a fault it detected between the DAC code driven by the digital core and an inverted copy.  | 0x0   | R/W-1-C |
| 5    | CAL_MEM_CRC_ERR        | This bit flags a CRC error for the CRC calculation of the calibration memory upon refresh.   | 0x0   | R/W-1-C |
| 4    | INVALID_SPI_ACCESS_ERR | This bit flags if an invalid SPI access is attempted, such as writing to or<br>reading from an invalid or reserved address. This bit also flags if an SPI write<br>is attempted directly after powering up but before a calibration memory<br>refresh is performed or if an SPI write is attempted while a calibration<br>memory refresh is in progress. Performing a two stage readback is permitted<br>during a calibration memory refresh and does not cause this flag to set.<br>Attempting to write to a read only register also causes this bit to assert. | 0x0   | R/W-1-C |
| 3    | Reserved               | Reserved.  | 0x0   | R/W-1-C |
| 2    | SCLK_COUNT_ERR         | This bit flags an SCLK falling edge count error. 32 clocks are required if SPI CRC is enabled and 24 clocks or 32 clocks are required if SPI CRC is not enabled.   | 0x0   | R/W-1-C |
| 1    | SLIPBIT_ERR            | This bit flags an SPI frame slip bit error, that is, the MSB of the SPI word is not equal to the inverse of MSB – 1.   | 0x0   | R/W-1-C |
| 0    | SPI_CRC_ERR            | This bit flags an SPI CRC error.   | 0x0   | R/W-1-C |

#### Analog Diagnostic Results Register

### Address: 0x15, Reset: 0x150000, Name: ANALOG\_DIAG\_RESULTS

This register contains an error flag corresponding to the four voltage nodes ( $V_{LDO}$ , INT\_AVCC, REFIN, and REFOUT) monitored in the background by comparators, as well as a flag for the main die temperature, which is also monitored by a comparator. Voltage output short circuit, current output open circuit, fault protection switch, and dc-to-dc error flags are also contained in this register. Like the DIGITAL\_DIAG\_RESULTS register, all of the flags contained in this register require a 1 to be written to them to update or clear them. When the corresponding diagnostic features are not enabled, the respective error flags are read as zero.

| Bits Bit Name Description |                   | Description   | Reset | Access  |  |
|---------------------------|-------------------|---|-------|---------|--|
| 21                        | FAULT_PIN_STATUS  | The FAULT_PIN_STATUS bit reflects the inverted current status of the FAULT pin.   |       | R       |  |
| [20:16]                   | REGISTER_ADDRESS  | Register address.   | 0x0   | R       |  |
| [15:14]                   | Reserved          | Reserved.   | 0x0   | RO      |  |
| 13                        | FAULT_PROT_SW_ERR | This bit flags if the fault protection switch at the $V_{IOUT}$ pin goes outside of the $V_{DPC+}$ or and or AV <sub>ss</sub> rail, irrespective of whether the fault protection switch is currently open (disabled) or closed (enabled).                                       |       | R/W-1-C |  |
| 12                        | Reserved          | Reserved.   | 0x0   | R/W-1-C |  |
| 11                        | DCDC_P_SC_ERR     | This bit flags a dc-to-dc short-circuit error for the positive rail dc-to-dc circuit.   |       | R/W-1-C |  |
| 10                        | Reserved          | Reserved.   |       | R/W-1-C |  |
| 9                         | DCDC_P_PWR_ERR    | This bit flags a dc-to-dc regulation fault, that is, the dc-to-dc circuitry cannot reach the target $V_{DPC+}$ voltage due to an insufficient $AV_{DD1}$ voltage.   |       | R/W-1-C |  |
| 8                         | Reserved          | Reserved. (   |       | R/W-1-C |  |
| 7                         | IOUT_OC_ERR       | This bit flags a current output open circuit error. This error bit is set in the case of a current output open circuit and in the case where there is insufficient headroom available to the internal current output driver circuitry to provide the programmed output current. | 0x0   | R/W-1-C |  |
| 6                         | VOUT_SC_ERR       | This bit flags a voltage output short-circuit error.  | 0x0   | R/W-1-C |  |
| 5                         | Reserved          | Reserved.   | 0x0   | R/W-1-C |  |

#### Table 46. Bit Descriptions for ANALOG\_DIAG\_RESULTS

| Bits | ts Bit Name Description |   | Reset | Access  |
|------|-------------------------|---|-------|---------|
| 4    | MAIN_DIE_TEMP_ERR       | This bit flags an overtemperature error for the main die.   |       | R/W-1-C |
| 3    | REFOUT_ERR              | This bit flags that the REFOUT node is outside of the comparator threshold levels or if its short-circuit current limit occurs.           |       | R/W-1-C |
| 2    | REFIN_ERR               | This bit flags that the REFIN node is outside of the comparator threshold levels.   |       | R/W-1-C |
| 1    | INT_AVCC_ERR            | This bit flags that the INT_AVCC node is outside of the comparator threshold levels.  |       | R/W-1-C |
| 0    | VLDO_ERR                | This bit flags that the V <sub>LDO</sub> node is outside of the comparator threshold levels or if its short-circuit current limit occurs. | 0x0   | R/W-1-C |

### **Status Register**

# Address: 0x16, Reset: 0x100000, Name: Status

This register contains ADC data and status bits, as well as the WDT, OR'd analog and digital diagnostics, and the FAULT pin status bits.

#### Table 47. Bit Descriptions for Status

| Bits    | Bit Name         | Description  | Reset | Access |
|---------|------------------|--|-------|--------|
| 21      | FAULT_PIN_STATUS | The FAULT_PIN_STATUS bit reflects the inverted current status of the FAULT pin.  |       | R      |
| 20      | DIG_DIAG_STATUS  | This bit represents the result of a logical OR of the contents of Bits[15:0] in the DIGITAL_<br>DIAG_RESULTS register, with the exception of the SLEW_BUSY bit. Therefore, if any of<br>these bits are high, the DIG_DIAG_STATUS bit is high. Note that this bit is high on<br>power-up due to the active RESET_OCCURRED flag. A quiet mode is also available<br>(SPI_DIAG_QUIET_EN in the GP_CONFIG1 register), such that the logical OR function<br>only incorporates Bits[D15:D3] of the DIGITAL_DIAG_RESULTS register (with the<br>exception of the SLEW_BUSY bit). If an SPI CRC, SPI slip bit, or SCLK count error occurs,<br>the DIG_DIAG_STATUS bit is not set high. | 0x1   | R      |
| 19      | ANA_DIAG_STATUS  | This bit represents the result of a logical OR of the contents of Bits[13:0] in the ANALOG_DIAG_RESULTS register. Therefore, if any bit in this register is high, the ANA_DIAG_STATUS bit is high.   | 0x0   | R      |
| 18      | WDT_STATUS       | WDT status bit.  | 0x0   | R      |
| 17      | ADC_BUSY         | ADC busy status bit.   | 0x0   | R      |
| [16:12] | ADC_CH           | Address of the ADC channel represented by the ADC_DATA bits in the status register.  |       | R      |
| [11:0]  | ADC_DATA         | 12 bits of ADC data representing the converted signal addressed by the ADC_CH bits, Bits[4:0].   | 0x0   | R      |

#### Chip ID Register

# Address: 0x17, Reset: 0x170101, Name: CHIP\_ID

This register contains the silicon revision ID of both the main die and the dc-to-dc die.

#### Table 48. Bit Descriptions for CHIP\_ID

| Bits    | Bit Name         | Description   | Reset | Access |
|---------|------------------|---|-------|--------|
| 21      | FAULT_PIN_STATUS | The FAULT_PIN_STATUS bit reflects the inverted current status of the FAULT pin. | 0x0   | R      |
| [20:16] | REGISTER_ADDRESS | Register address.   | 0x0   | R      |
| [15:11] | Reserved         | Reserved.   | 0x0   | RO     |
| [10:8]  | DCDC_DIE_CHIP_ID | These bits reflect the silicon revision number of the dc-to-dc die.             | 0x1   | R      |
| [7:0]   | MAIN_DIE_CHIP_ID | These bits reflect the silicon revision number of the main die.                 | 0x1   | R      |

### Frequency Monitor Register

#### Address: 0x18, Reset: 0x180000, Name: FREQ\_MONITOR

An internal frequency monitor uses the internal oscillator (MCLK) to create a pulse at a frequency of 1 kHz (MCLK/10,000). This pulse is used to increment a 16-bit counter. The value of the counter is available to read in the FREQ\_MONITOR register. The user can poll this register periodically and use it both as a diagnostic tool for the internal oscillator (to monitor that the oscillator is running) and to measure the frequency. This feature is enabled by default via the FREQ\_MON\_EN bit in the DIGITAL\_DIAG\_CONFIG register.

#### Table 49. Bit Descriptions for FREQ\_MONITOR

| Bits    | Bit Name         | Description   | Reset | Access |
|---------|------------------|---|-------|--------|
| 21      | FAULT_PIN_STATUS | The FAULT_PIN_STATUS bit reflects the inverted current status of the FAULT pin. | 0x0   | R      |
| [20:16] | REGISTER_ADDRESS | Register address.   | 0x0   | R      |
| [15:0]  | FREQ_MONITOR     | Internal clock counter value.   | 0x0   | R      |

#### **Generic ID Register**

Address: 0x1C, Reset: 0x1C0000, Name: DEVICE\_ID\_3

# Table 50. Bit Descriptions for DEVICE\_ID\_3

| Bits    | Bit Name Description |  | Reset | Access |  |
|---------|----------------------|--|-------|--------|--|
| 21      | FAULT_PIN_STATUS     | S The FAULT_PIN_STATUS bit reflects the inverted current status of the FAULT pin |       | R      |  |
| [20:16] | REGISTER_ADDRESS     | Register address.  | 0x0   | R      |  |
| [15:8]  | Reserved             | Reserved.  | 0x0   | R      |  |
| [7:3]   | Reserved             | Reserved.  | 0x0   | R      |  |
| [2:0]   | Generic ID           | Generic ID.  | 0x0   | R      |  |
|         |                      | 000: reserved  |       |        |  |
|         |                      | 001: reserved  |       |        |  |
|         |                      | 010: AD5758  |       |        |  |
|         |                      | 011: reserved  |       |        |  |
|         |                      | 100: reserved  |       |        |  |
|         |                      | 101: reserved  |       |        |  |
|         |                      | 110: reserved  |       |        |  |
|         |                      | 111: reserved  |       |        |  |

# APPLICATIONS INFORMATION EXAMPLE MODULE POWER CALCULATION

Using the example module shown in Figure 93, the module power dissipation (excluding the power dissipated in the load) can be calculated using the methodology shown in the Power Calculation Methodology (RLOAD = 1 k $\Omega$ ) section. Assuming a maximum I<sub>OUT</sub> value of 20 mA and R<sub>LOAD</sub> value of 1 k $\Omega$ , the total module power is calculated as approximately 226 mW. Note that power associated with the external digital isolation is not included in the calculations because this power is dependent on the choice of component used.

Replacing the 1 k $\Omega$  load with a short circuit, the power dissipation calculation is shown in the Power Calculation Methodology (RLOAD = 0  $\Omega$ ) section, which shows that the total module power becomes approximately 206 mW in a short-circuit load condition.

#### Power Calculation Methodology ( $R_{LOAD} = 1 \ k\Omega$ )

| Table 51. Quiescent Current Power Calculation |                           |            |  |  |  |
|---|---------------------------|------------|--|--|--|
| Voltage (V)                                   | Current (mA)              | Power (mW) |  |  |  |
| $AV_{DD1} = 24$                               | $AI_{DD1} = 0.05$         | 1.2        |  |  |  |
| $AV_{DD2} = 5$                                | $AI_{DD2} = 2.9$          | 14.5       |  |  |  |
| $AV_{ss} = -15$                               | $AI_{SS} = 0.23$          | 3.45       |  |  |  |
| $V_{\text{LOGIC}} = 3.3$                      | $I_{\text{LOGIC}} = 0.01$ | 0.033      |  |  |  |

Using the voltage and current values in Table 51, the total quiescent current power is 19.18 mW.

Next, perform the following calculation:

 $(V_{DPC+}) \times (20 \text{ mA} + I_{DPC+}) = 22.5 \text{ V} \times 20.5 \text{ mA} = 461.25 \text{ mW}$ 

Assume the dc-to-dc converter is at 90% efficiency. Therefore,  $V_{DPC+}$  power = 512.5 mW. The total input power at the AD5758 side of the isolated dc-to-dc power module is therefore 512.5 mW + 19.18 mW = 531.68 mW. Subtracting the 400 mW load power from this value gives the power associated only with the AD5758, which is 131.68 mW.

Assuming an 85% efficiency isolated, dc-to-dc power module, the total input power becomes 625.5 mW (see Figure 93).

*Total Module Power = Input Power – Load Power* 

Therefore,

625.5 mW - 400 mW = 225.5 mW

#### Power Calculation Methodology ( $R_{LOAD} = 0 \Omega$ )

Using the voltage and current values in Table 51, the total quiescent current power is 19.18 mW.

Next,

$$(V_{DPC+}) \times (20 \text{ mA} + I_{DPC+}) = 4.95 \text{ V} \times 20.5 \text{ mA} = 101.5 \text{ mW}$$

Assume dc-to-dc converter at 65% efficiency. Therefore,  $V_{DPC+}$  power = 156.2 mW. The total input power at the AD5758 side of the isolated dc-to-dc power module is therefore 156.2 mW + 19.18 mW = 175.38 mW. Subtracting the 0 mW load power from this value gives the power associated only with the AD5758, which is 175.38 mW.

Assuming an 85% efficiency isolated, dc-to-dc power module, the total input power becomes 206.33 mW (see Figure 93).

*Total Module Power = Input Power – Load Power* 

Therefore,

206.33 mW - 0 mW = 206.33 mW



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# **DRIVING INDUCTIVE LOADS**

Driving pure inductive loads while the AD5758 is in a current output mode requires additional external components. Due to the operation of the fault protection switch, connecting a pure inductive load to the output causes a spike in voltage due to the back electromagnetic force (EMF) from the inductor. This spike can cause the fault protect switch to open and close indefinitely. For example, if the load wire on the screw terminal disconnects, a technician can reconnect the wire without disabling the AD5758 output. The reconnection of this wire onto a current output introduces the voltage spike caused by the back EMF. To avoid such issues, the inside of the fault protect switch on the AD5758 is available on the VI<sub>OUT\_INT</sub> pin. Connecting a 300  $\Omega$  resistor from  $VI_{\text{OUT\_INT}}$  to  $VI_{\text{OUT}}$  by passes the fault protection switch and avoids the oscillations. The additional external components are required to ensure that no oscillations occur when applying a current step into the inductive load, for example, a full-scale step from zero scale.



AD5758

Figure 94. Required External Components for Driving an Inductive Load

The recommended external components are as follows:

- R<sub>SHUNT</sub> = 300 Ω
- $C_{PIN} = 20 \text{ nF}$
- $C_{SCREW} = 10 \text{ nF}$
- $R_{ESD} = 50 \Omega$

# **OUTLINE DIMENSIONS**



# **ORDERING GUIDE**

| Model <sup>1</sup> | Temperature Range | Package Description                           | Package Option |
|--------------------|-------------------|---|----------------|
| AD5758BCPZ-REEL    | -40°C to +115°C   | 32-Lead Lead Frame Chip Scale Package [LFCSP] | CP-32-30       |
| AD5758BCPZ-RL7     | -40°C to +115°C   | 32-Lead Lead Frame Chip Scale Package [LFCSP] | CP-32-30       |
| EVAL-AD5758SDZ     |                   | Evaluation Board                              |                |

 $^{1}$  Z = RoHS Compliant Part.



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